

## TPS51200 Sink and Source DDR Termination Regulator

### 1 Features

- Input Voltage: Supports 2.5-V Rail and 3.3-V Rail
- VLDOIN Voltage Range: 1.1 V to 3.5 V
- Sink and Source Termination Regulator Includes Droop Compensation
- Requires Minimum Output Capacitance of 20- $\mu$ F (Typically 3  $\times$  10- $\mu$ F MLCCs) for Memory Termination Applications (DDR)
- PGOOD to Monitor Output Regulation
- EN Input
- REFIN Input Allows for Flexible Input Tracking Either Directly or Through Resistor Divider
- Remote Sensing (VOSNS)
- $\pm$ 10-mA Buffered Reference (REFOUT)
- Built-in Soft Start, UVLO, and OCL
- Thermal Shutdown
- Supports DDR, DDR2, DDR3, Low-Power DDR3, and DDR4 VTT Applications
- 10-Pin VSON Package With Thermal Pad

### 2 Applications

- Memory Termination Regulator for DDR, DDR2, DDR3, Low-Power DDR3 and DDR4
- Notebooks, Desktops, and Servers
- Telecom and Datacom
- Base Stations
- LCD-TVs and PDP-TVs
- Copiers and Printers
- Set-Top Boxes

### 3 Description

The TPS51200 device is a sink and source double data rate (DDR) termination regulator specifically designed for low input voltage, low-cost, low-noise systems where space is a key consideration.

The TPS51200 maintains a fast transient response and only requires a minimum output capacitance of 20  $\mu$ F. The TPS51200 supports a remote sensing function and all power requirements for DDR, DDR2, DDR3, Low-Power DDR3 and DDR4 VTT bus termination.

In addition, the TPS51200 provides an open-drain PGOOD signal to monitor the output regulation and an EN signal that can be used to discharge VTT during S3 (suspend to RAM) for DDR applications.

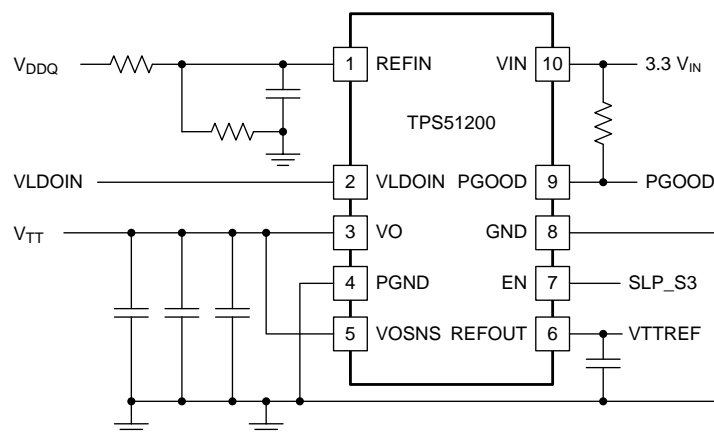
The is available in the thermally efficient 10-pin VSON thermal pad package, and is rated both Green and Pb-free. It is specified from  $-40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$ .

#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
TPS51200	VSON (10)	3.00 mm $\times$ 3.00 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

#### Simplified DDR Application



Copyright © 2016, Texas Instruments Incorporated



## Table of Contents

<b>1</b>	<b>Features</b> .....	<b>1</b>	<b>8</b>	<b>Application and Implementation</b> .....	<b>16</b>
<b>2</b>	<b>Applications</b> .....	<b>1</b>	8.1	Application Information.....	16
<b>3</b>	<b>Description</b> .....	<b>1</b>	8.2	Typical Application .....	16
<b>4</b>	<b>Revision History</b> .....	<b>2</b>	8.3	System Examples .....	19
<b>5</b>	<b>Pin Configuration and Functions</b> .....	<b>3</b>	<b>9</b>	<b>Power Supply Recommendations</b> .....	<b>25</b>
<b>6</b>	<b>Specifications</b> .....	<b>4</b>	<b>10</b>	<b>Layout</b> .....	<b>25</b>
6.1	Absolute Maximum Ratings .....	4	10.1	Layout Guidelines .....	25
6.2	ESD Ratings.....	4	10.2	Layout Example .....	26
6.3	Recommended Operating Conditions.....	4	10.3	Thermal Design Considerations.....	26
6.4	Thermal Information .....	4	<b>11</b>	<b>Device and Documentation Support</b> .....	<b>28</b>
6.5	Electrical Characteristics.....	5	11.1	Device Support.....	28
6.6	Typical Characteristics .....	6	11.2	Documentation Support .....	28
<b>7</b>	<b>Detailed Description</b> .....	<b>9</b>	11.3	Community Resources.....	28
7.1	Overview .....	9	11.4	Trademarks .....	28
7.2	Functional Block Diagram .....	9	11.5	Electrostatic Discharge Caution.....	28
7.3	Feature Description.....	9	11.6	Glossary .....	28
7.4	Device Functional Modes.....	15	<b>12</b>	<b>Mechanical, Packaging, and Orderable Information</b> .....	<b>29</b>

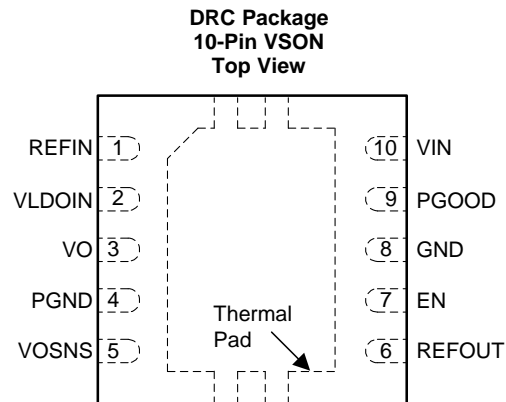
## 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

<b>Changes from Revision A (September 2015) to Revision B</b>	<b>Page</b>
• Added test condition to <i>Output DC voltage</i> , <i>VO</i> specification .....	5
• Changed " $-10\text{ mA} < I_{\text{REFOUT}} < 10\text{ mA}$ " to " $-1\text{ mA} < I_{\text{REFOUT}} < 1\text{ mA}$ " in all test conditions for the <i>REFOUT voltage tolerance to <math>V_{\text{REFIN}}</math></i> specification .....	5
• Changed all MIN and MAX values from "15" to "12" for all test conditions for the <i>REFOUT voltage tolerance to <math>V_{\text{REFIN}}</math></i> specification .....	5
• Updated <a href="#">Figure 16</a> .....	10
• Added <a href="#">REFOUT (<math>V_{\text{REF}}</math>) Consideration for DDR2 Applications</a> section.....	14
• Updated <a href="#">Figure 25</a> and <a href="#">Table 4</a> .....	19
• Added clarity to <a href="#">Layout Guidelines</a> section. ....	25

<b>Changes from Original (February 2008) to Revision A</b>	<b>Page</b>
• Added <i>Pin Configuration and Functions</i> section, <i>ESD Rating</i> table, <i>Feature Description</i> section, <i>Device Functional Modes</i> , <i>Application and Implementation</i> section, <i>Power Supply Recommendations</i> section, <i>Layout</i> section, <i>Device and Documentation Support</i> section, and <i>Mechanical, Packaging, and Orderable Information</i> section. ....	1
• Changed "PowerPAD" references to "thermal pad" throughout .....	3
• Deleted <i>Dissipation Ratings</i> table .....	4

## 5 Pin Configuration and Functions



**Table 1. Pin Functions**

PIN		I/O <sup>(1)</sup>	DESCRIPTION
NAME	NO.		
EN	7	I	For DDR VTT application, connect EN to SLP_S3. For any other application, use the EN pin as the ON/OFF function.
GND	8	G	Signal ground.
PGND <sup>(2)</sup>	4	G	Power ground for the LDO.
PGOOD	9	O	Open-drain, power-good indicator.
REFIN	1	I	Reference input.
REFOUT	6	O	Reference output. Connect to GND through 0.1- $\mu$ F ceramic capacitor.
VIN	10	I	2.5-V or 3.3-V power supply. A ceramic decoupling capacitor with a value between 1- $\mu$ F and 4.7- $\mu$ F is required.
VLDOIN	2	I	Supply voltage for the LDO.
VO	3	O	Power output for the LDO.
VOSNS	5	I	Voltage sense input for the LDO. Connect to positive terminal of the output capacitor or the load.

(1) I = Input, O = Output, G = Ground

(2) Thermal pad connection. See [Figure 32](#) in the *Thermal Design Considerations* section for additional information.

## 6 Specifications

### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) <sup>(1)</sup>

		MIN	MAX	UNIT
Input voltage <sup>(2)</sup>	REFIN, VIN, VLDOIN, VOSNS	-0.3	3.6	V
	EN	-0.3	6.5	
	PGND to GND	-0.3	0.3	
Output voltage <sup>(2)</sup>	REFOUT, VO	-0.3	3.6	V
	PGOOD	-0.3	6.5	
Operating junction temperature, T <sub>J</sub>		-40	150	°C
Storage temperature, T <sub>stg</sub>		-55	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values are with respect to the network ground terminal unless otherwise noted.

### 6.2 ESD Ratings

		VALUE	UNIT
V <sub>(ESD)</sub>	Electrostatic discharge		
	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±2000	V
Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	±500		

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
Supply voltages	VIN	2.375		3.500	V
Voltage	EN, VLDOIN, VOSNS	-0.1		3.5	V
	REFIN	0.5		1.8	
	PGOOD, VO	-0.1		3.5	
	REFOUT	-0.1		1.8	
	PGND	-0.1		0.1	
Operating free-air temperature, T <sub>A</sub>		-40		85	°C

### 6.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>		TPS51200	UNIT
		DRC (VSON)	
		10 PINS	
R <sub>θJA</sub>	Junction-to-ambient thermal resistance	55.6	°C/W
R <sub>θJC(top)</sub>	Junction-to-case (top) thermal resistance	84.6	°C/W
R <sub>θJB</sub>	Junction-to-board thermal resistance	30.0	°C/W
ψ <sub>JT</sub>	Junction-to-top characterization parameter	5.5	°C/W
ψ <sub>JB</sub>	Junction-to-board characterization parameter	30.1	°C/W
R <sub>θJC(bot)</sub>	Junction-to-case (bottom) thermal resistance	10.9	°C/W

- (1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, [SPRA953](http://www.ti.com/lit/zip/Spra953).

## 6.5 Electrical Characteristics

Over recommended free-air temperature range,  $V_{VIN} = 3.3\text{ V}$ ,  $V_{VLDOIN} = 1.8\text{ V}$ ,  $V_{REFIN} = 0.9\text{ V}$ ,  $V_{VOSNS} = 0.9\text{ V}$ ,  $V_{EN} = V_{VIN}$ ,  $C_{OUT} = 3 \times 10\ \mu\text{F}$  and circuit shown in [Figure 21](#). (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
<b>SUPPLY CURRENT</b>							
$I_{IN}$	Supply current	$T_A = 25\text{ }^\circ\text{C}$ , $V_{EN} = 3.3\text{ V}$ , No Load		0.7	1	mA	
$I_{IN(SDN)}$	Shutdown current	$T_A = 25\text{ }^\circ\text{C}$ , $V_{EN} = 0\text{ V}$ , $V_{REFIN} = 0$ , No Load		65	80	$\mu\text{A}$	
		$T_A = 25\text{ }^\circ\text{C}$ , $V_{EN} = 0\text{ V}$ , $V_{REFIN} > 0.4\text{ V}$ , No Load		200	400		
$I_{LDOIN}$	Supply current of VLDOIN	$T_A = 25\text{ }^\circ\text{C}$ , $V_{EN} = 3.3\text{ V}$ , No Load		1	50	$\mu\text{A}$	
$I_{LDOIN(SDN)}$	Shutdown current of VLDOIN	$T_A = 25\text{ }^\circ\text{C}$ , $V_{EN} = 0\text{ V}$ , No Load		0.1	50	$\mu\text{A}$	
<b>INPUT CURRENT</b>							
$I_{REFIN}$	Input current, REFIN	$V_{EN} = 3.3\text{ V}$			1	$\mu\text{A}$	
<b>VO OUTPUT</b>							
$V_{VOSNS}$	Output DC voltage, VO	$V_{REFOUT} = 1.25\text{ V}$ (DDR1), $I_O = 0\text{ A}$		1.25		V	
				-15	15	mV	
		$V_{REFOUT} = 0.9\text{ V}$ (DDR2), $I_O = 0\text{ A}$		0.9		V	
				-15	15	mV	
		$V_{LDOIN} = 1.5\text{ V}$ , $V_{REFOUT} = 0.75\text{ V}$ (DDR3), $I_O = 0\text{ A}$		0.75		V	
		-15	15	mV			
		$V_{REFOUT} = 0.6\text{ V}$ (DDR4), $I_O = 0\text{ A}$		0.6		V	
		-15	15	mV			
$V_{VOTOL}$	Output voltage tolerance to REFOUT	$-2\text{ A} < I_{VO} < 2\text{ A}$		-25	25	mV	
$I_{VOSRCL}$	VO source current Limit	With reference to REFOUT, $V_{OSNS} = 90\% \times V_{REFOUT}$		3	4.5	A	
$I_{VOSNCL}$	VO sink current Limit	With reference to REFOUT, $V_{OSNS} = 110\% \times V_{REFOUT}$		3.5	5.5	A	
$I_{DSCHRG}$	Discharge current, VO	$V_{REFIN} = 0\text{ V}$ , $V_{VO} = 0.3\text{ V}$ , $V_{EN} = 0\text{ V}$ , $T_A = 25\text{ }^\circ\text{C}$		18	25	$\Omega$	
<b>POWERGOOD COMPARATOR</b>							
$V_{TH(PG)}$	VO PGOOD threshold	PGOOD window lower threshold with respect to REFOUT		-23.5%	-20%	-17.5%	
		PGOOD window upper threshold with respect to REFOUT		17.5%	20%	23.5%	
		PGOOD hysteresis		5%			
$t_{PGSTUPDLY}$	PGOOD start-up delay	Start-up rising edge, VOSNS within 15% of REFOUT		2		ms	
$V_{PGOODLOW}$	Output low voltage	$I_{SINK} = 4\text{ mA}$			0.4	V	
$t_{PBADDLY}$	PGOOD bad delay	VOSNS is outside of the $\pm 20\%$ PGOOD window		10		$\mu\text{s}$	
$I_{PGOODLK}$	Leakage current <sup>(1)</sup>	$V_{OSNS} = V_{REFIN}$ (PGOOD high impedance), $V_{PGOOD} = V_{VIN} + 0.2\text{ V}$			1	$\mu\text{A}$	
<b>REFIN AND REFOUT</b>							
$V_{REFIN}$	REFIN voltage range			0.5	1.8	V	
$V_{REFINUVLO}$	REFIN undervoltage lockout	REFIN rising		360	390	420	mV
$V_{REFINUVHYS}$	REFIN undervoltage lockout hysteresis			20		mV	
$V_{REFOUT}$	REFOUT voltage			REFIN		V	
$V_{REFOUTTOL}$	REFOUT voltage tolerance to $V_{REFIN}$	$-1\text{ mA} < I_{REFOUT} < 1\text{ mA}$ , $V_{REFIN} = 1.25\text{ V}$		12	12	mV	
		$-1\text{ mA} < I_{REFOUT} < 1\text{ mA}$ , $V_{REFIN} = 0.9\text{ V}$		12	12		
		$-1\text{ mA} < I_{REFOUT} < 1\text{ mA}$ , $V_{REFIN} = 0.75\text{ V}$		12	12		
		$-1\text{ mA} < I_{REFOUT} < 1\text{ mA}$ , $V_{REFIN} = 0.6\text{ V}$		12	12		

(1) Ensured by design. Not production tested.

### Electrical Characteristics (continued)

Over recommended free-air temperature range,  $V_{VIN} = 3.3\text{ V}$ ,  $V_{VLDIOIN} = 1.8\text{ V}$ ,  $V_{REFIN} = 0.9\text{ V}$ ,  $V_{VOSNS} = 0.9\text{ V}$ ,  $V_{EN} = V_{VIN}$ ,  $C_{OUT} = 3 \times 10\ \mu\text{F}$  and circuit shown in Figure 21. (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
$I_{REFOUTSRCL}$	REFOUT source current limit	$V_{REFOUT} = 0\text{ V}$	10	40	mA	
$I_{REFOUTSNCL}$	REFOUT sink current limit	$V_{REFOUT} = 0\text{ V}$	10	40	mA	
<b>UVLO AND EN LOGIC THRESHOLD</b>						
$V_{VINUVIN}$	UVLO threshold	Wake up, $T_A = 25^\circ\text{C}$	2.2	2.3	2.375	V
		Hysteresis		50		mV
$V_{ENIH}$	High-level input voltage	Enable	1.7			V
$V_{ENIL}$	Low-level input voltage	Enable		0.3		
$V_{ENYST}$	Hysteresis voltage	Enable		0.5		
$I_{ENLEAK}$	Logic input leakage current	EN, $T_A = 25^\circ\text{C}$	-1		1	$\mu\text{A}$
<b>THERMAL SHUTDOWN</b>						
$T_{SON}$	Thermal shutdown threshold <sup>(1)</sup>	Shutdown temperature		150		$^\circ\text{C}$
		Hysteresis		25		

### 6.6 Typical Characteristics

$3 \times 10\text{-mF}$  MLCCs (0805) are used on the output

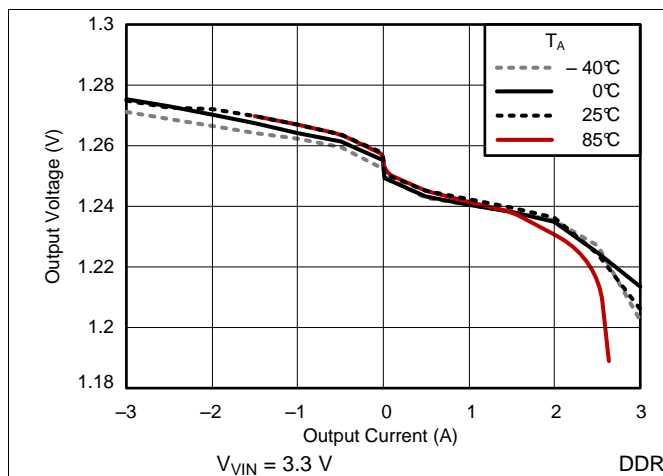


Figure 1. Load Regulation

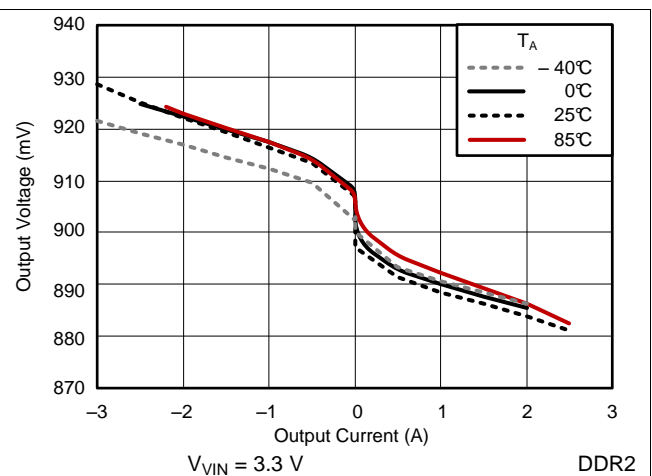


Figure 2. Load Regulation

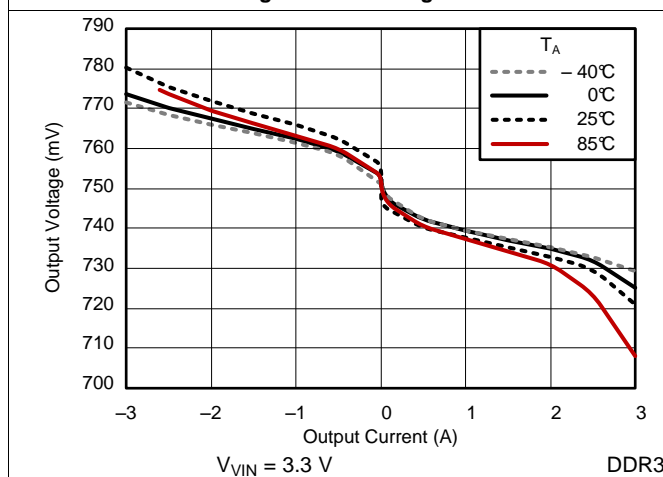


Figure 3. Load Regulation

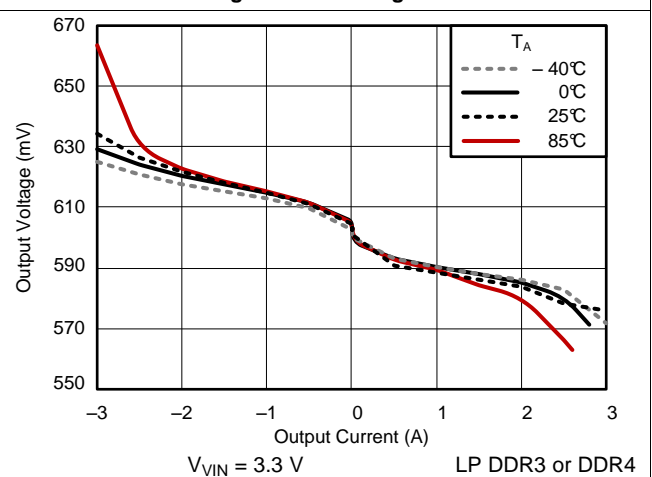
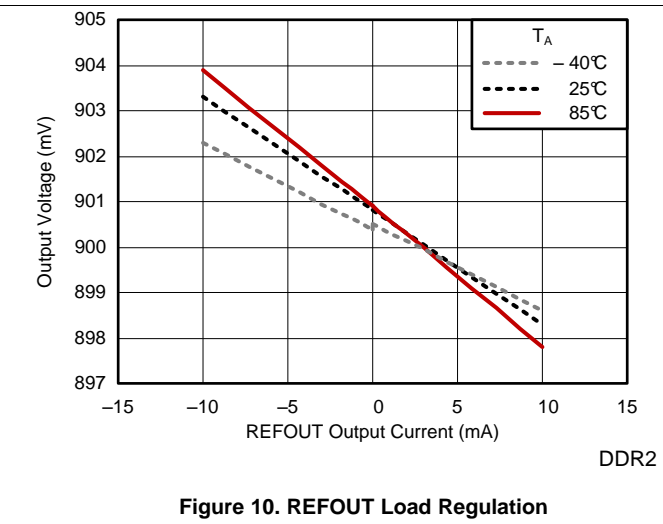
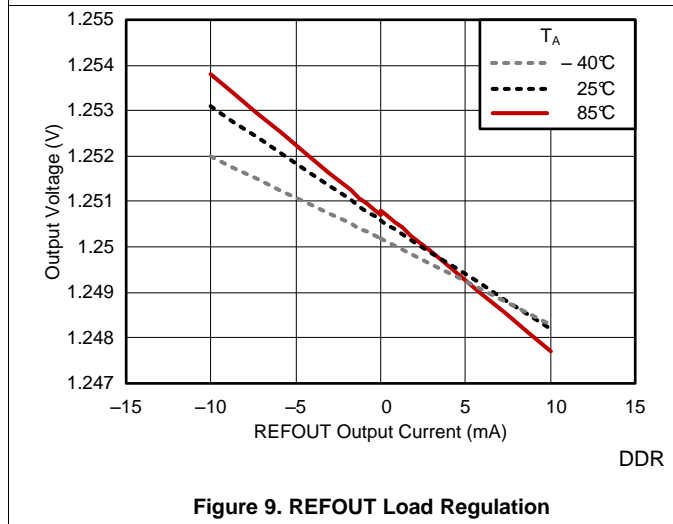
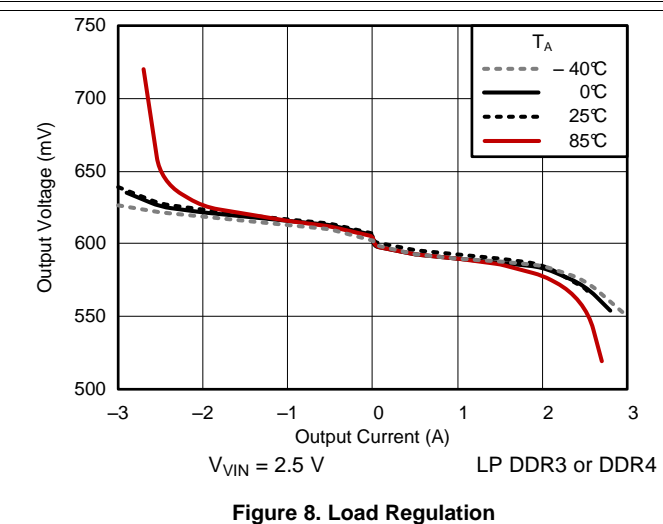
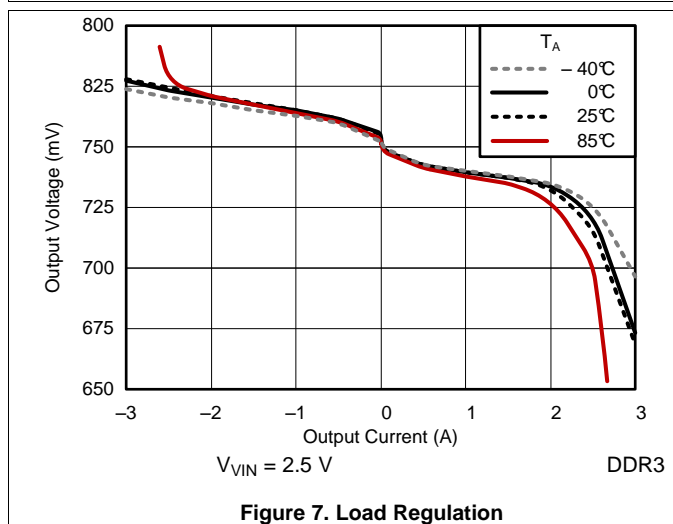
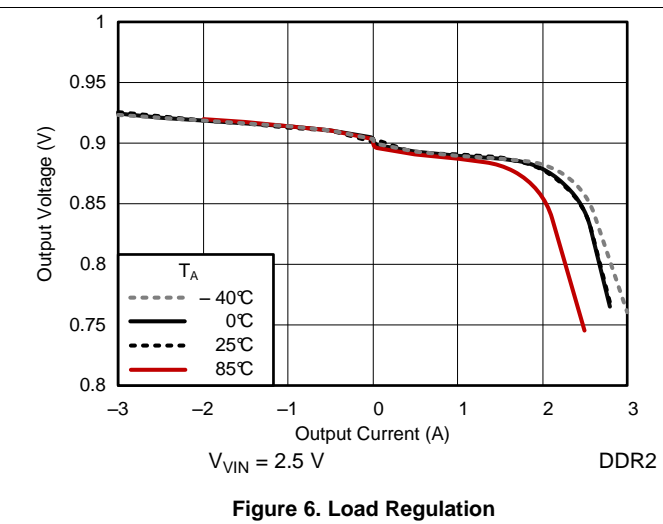
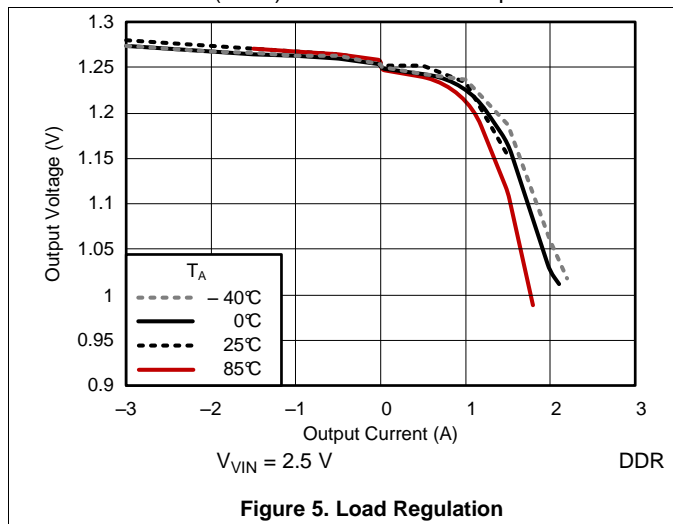


Figure 4. Load Regulation

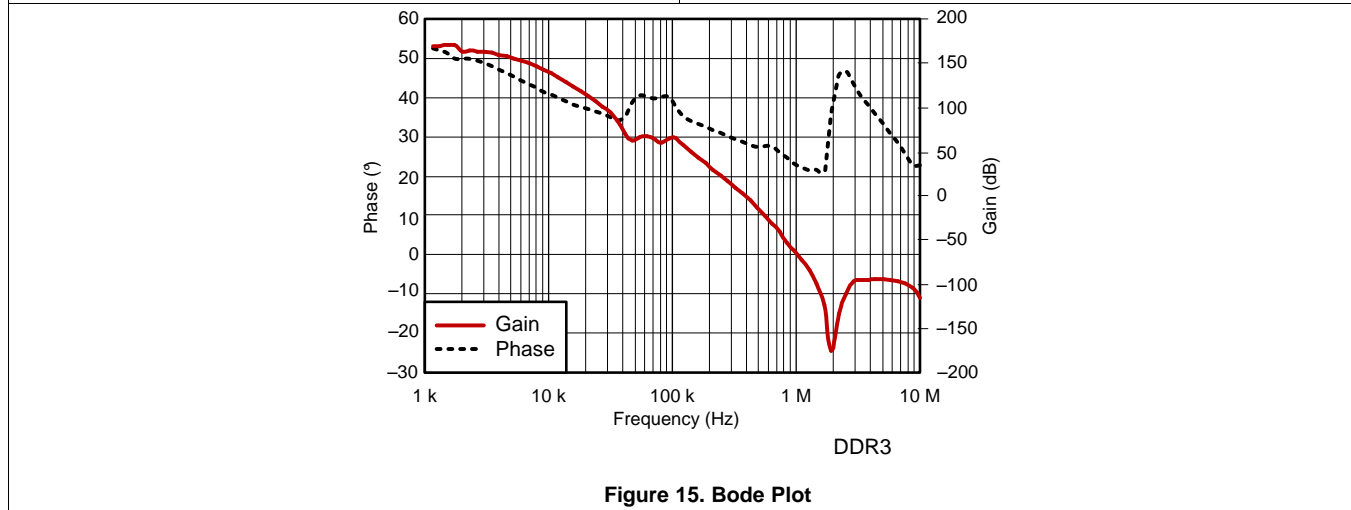
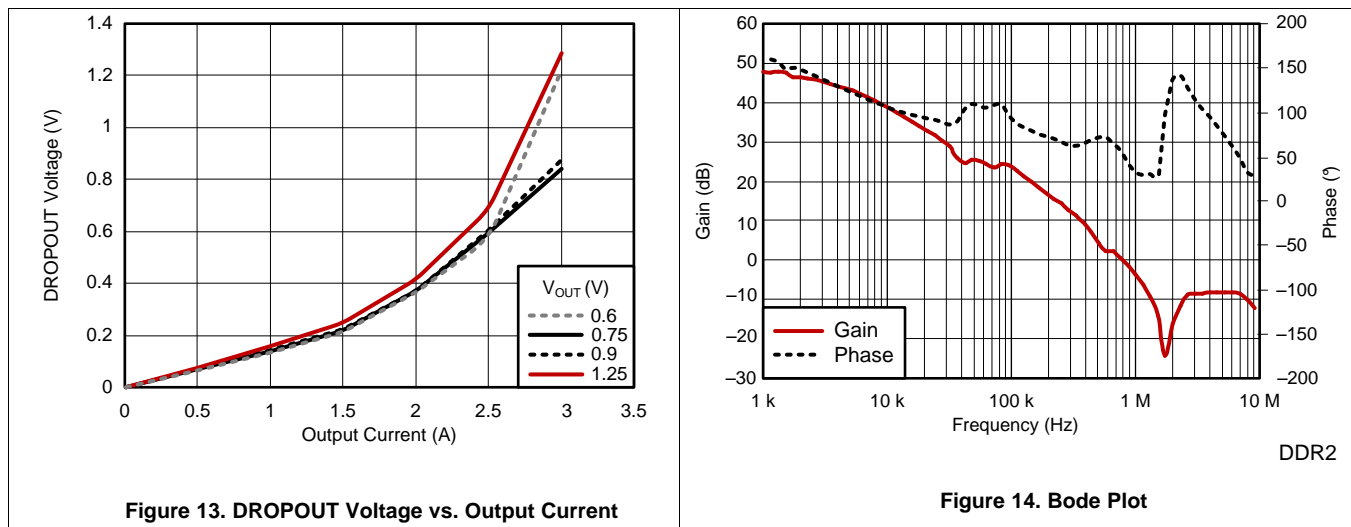
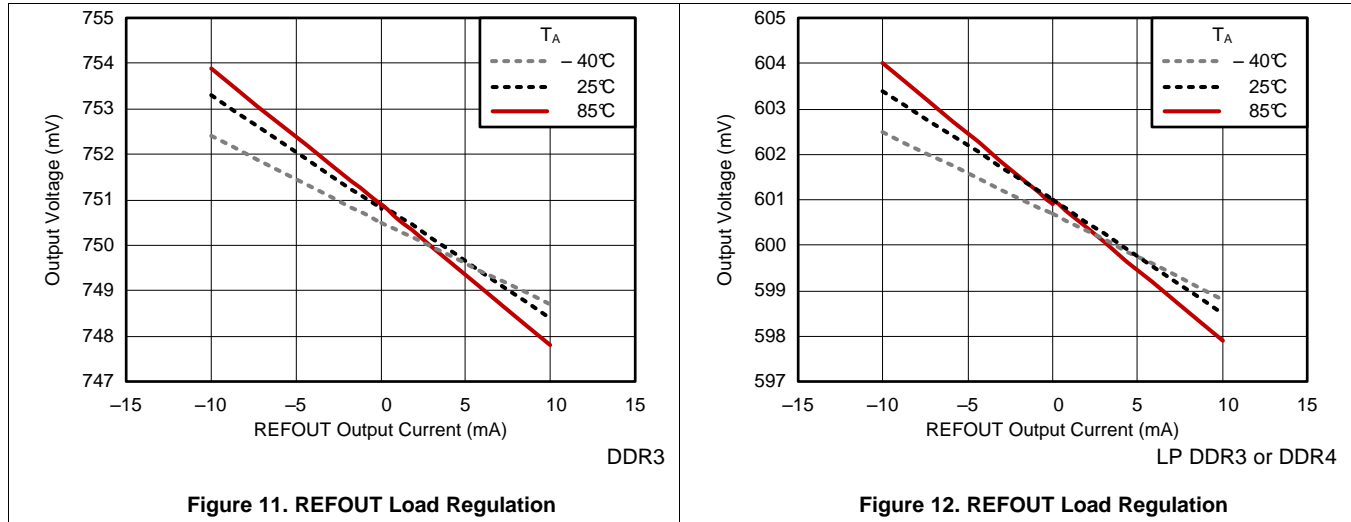
Typical Characteristics (continued)

3 × 10-mF MLCCs (0805) are used on the output



Typical Characteristics (continued)

3 × 10-mF MLCCs (0805) are used on the output





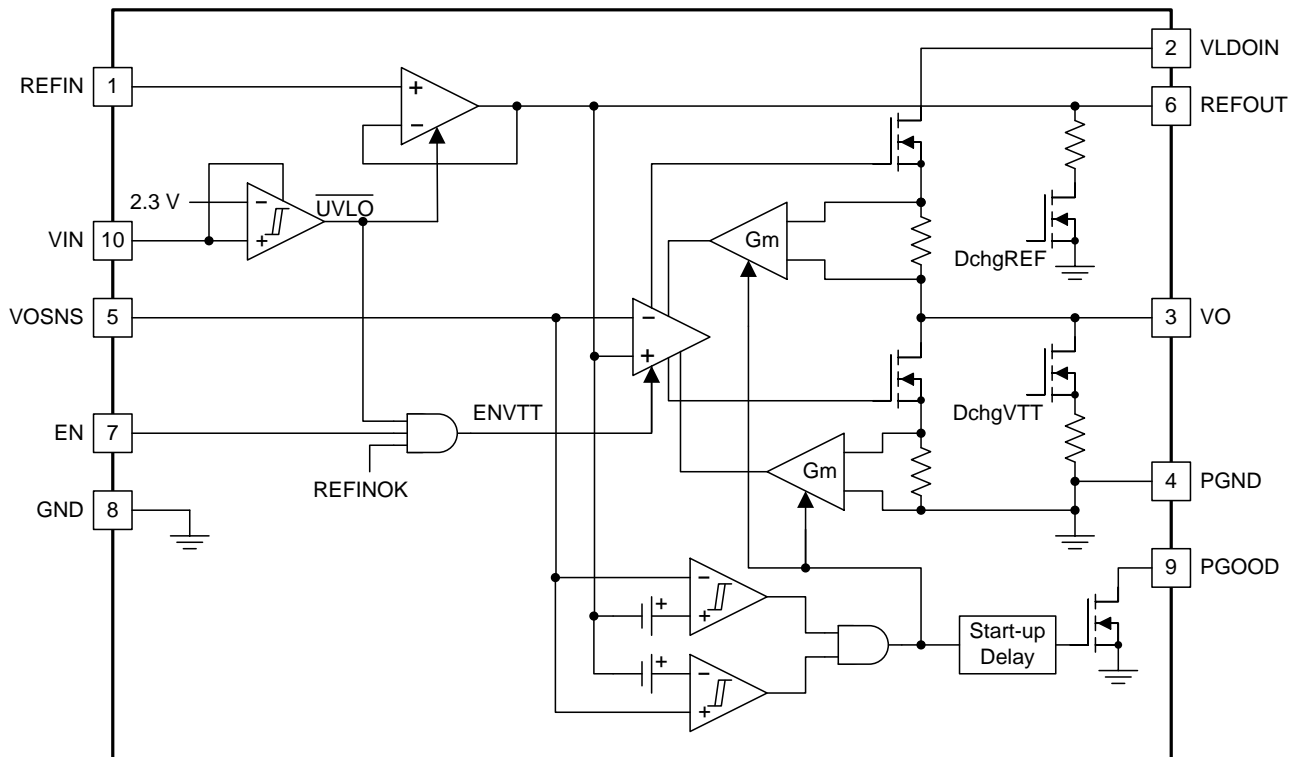
## 7 Detailed Description

### 7.1 Overview

The TPS51200 device is a sink and source double data rate (DDR) termination regulator specifically designed for low input voltage, low-cost, low-noise systems where space is a key consideration.

The device maintains a fast transient response and only requires a minimum output capacitance of 20  $\mu\text{F}$ . The device supports a remote sensing function and all power requirements for DDR, DDR2, DDR3, Low Power DDR3, and DDR4 VTT bus termination.

### 7.2 Functional Block Diagram



Copyright © 2016, Texas Instruments Incorporated

### 7.3 Feature Description

#### 7.3.1 Sink and Source Regulator (VO Pin)

The TPS51200 is a sink and source tracking termination regulator specifically designed for low input voltage, low-cost, and low external component count systems where space is a key application parameter. The device integrates a high-performance, low-dropout (LDO) linear regulator that is capable of both sourcing and sinking current. The LDO regulator employs a fast feedback loop so that small ceramic capacitors can be used to support the fast load transient response. To achieve tight regulation with minimum effect of trace resistance, connect a remote sensing terminal, VOSNS, to the positive terminal of each output capacitor as a separate trace from the high current path from VO.

#### 7.3.2 Reference Input (REFIN Pin)

The output voltage, VO, is regulated to REFOUT. When REFIN is configured for standard DDR termination applications, REFIN can be set by an external equivalent ratio voltage divider connected to the memory supply bus (VDDQ). The TPS51200 device supports REFIN voltages from 0.5 V to 1.8 V, making it versatile and ideal for many types of low-power LDO applications.

## Feature Description (continued)

### 7.3.3 Reference Output (REFOUT Pin)

When it is configured for DDR termination applications, REFOUT generates the DDR VTT reference voltage for the memory application. It is capable of supporting both a sourcing and sinking load of 10 mA. REFOUT becomes active when REFIN voltage rises to 0.390 V and VIN is above the UVLO threshold. When REFOUT is less than 0.375 V, it is disabled and subsequently discharges to GND through an internal 10-k $\Omega$  MOSFET. REFOUT is independent of the EN pin state.

### 7.3.4 Soft-Start Sequencing

A current clamp implements the soft-start function of the VO pin. The current clamp allows the output capacitors to be charged with low and constant current, providing a linear ramp-up of the output voltage. When VO is outside of the powergood window, the current clamp level is one-half of the full overcurrent limit (OCL) level. When VO rises or falls within the PGOOD window, the current clamp level switches to the full OCL level. The soft-start function is completely symmetrical and the overcurrent limit works for both directions. The soft-start function works not only from GND to the REFOUT voltage, but also from VLDOIN to the REFOUT voltage.

### 7.3.5 Enable Control (EN Pin)

When EN is driven high, the VO regulator begins normal operation. When the device drives EN low, VO discharges to GND through an internal 18- $\Omega$  MOSFET. REFOUT remains on when the device drives EN low. Ensure that the EN pin voltage remains lower than or equal to  $V_{VIN}$  at all times.

### 7.3.6 Powergood Function (PGOOD Pin)

The TPS51200 device provides an open-drain PGOOD output that goes high when the VO output is within  $\pm 20\%$  of REFOUT. PGOOD de-asserts within 10  $\mu$ s after the output exceeds the size of the powergood window. During initial VO start-up, PGOOD asserts high 2 ms (typ) after the VO enters power good window. Because PGOOD is an open-drain output, a pull-up resistor with a value between 1 k $\Omega$  and 100 k $\Omega$ , placed between PGOOD and a stable active supply voltage rail is required.

### 7.3.7 Current Protection (VO Pin)

The LDO has a constant overcurrent limit (OCL). The OCL level reduces by one-half when the output voltage is not within the powergood window. This reduction is a non-latch protection.

### 7.3.8 UVLO Protection (VIN Pin)

For VIN undervoltage lockout (UVLO) protection, the TPS51200 monitors VIN voltage. When the VIN voltage is lower than the UVLO threshold voltage, both the VO and REFOUT regulators are powered off. This shutdown is a non-latch protection.

### 7.3.9 Thermal Shutdown

The TPS51200 monitors junction temperature. If the device junction temperature exceeds the threshold value, (typically 150°C), the VO and REFOUT regulators both shut off, discharged by the internal discharge MOSFETs. This shutdown is a non-latch protection.

### 7.3.10 Tracking Start-up and Shutdown

The TPS51200 also supports tracking start-up and shutdown when the EN pin is tied directly to the system bus and not used to turn on or turn off the device. During tracking start-up, VO follows REFOUT once REFIN voltage is greater than 0.39 V. REFIN follows the rise of VDDQ rail through a voltage divider. The typical soft-start time ( $t_{SS}$ ) for the VDDQ rail is approximately 3 ms, however it may vary depending on the system configuration. The soft-start time of the VO output no longer depends on the OCL setting, but it is a function of the soft-start time of the VDDQ rail. PGOOD is asserted 2 ms after  $V_{VO}$  is within  $\pm 20\%$  of REFOUT. During tracking shutdown, the VO pin voltage falls following REFOUT until REFOUT reaches 0.37 V. When REFOUT falls below 0.37 V, the internal discharge MOSFETs turn on and quickly discharge both REFOUT and VO to GND. PGOOD is deasserted when VO is beyond the  $\pm 20\%$  range of REFOUT. [Figure 17](#) shows the typical timing diagram for an application that uses tracking start-up and shutdown.

Feature Description (continued)

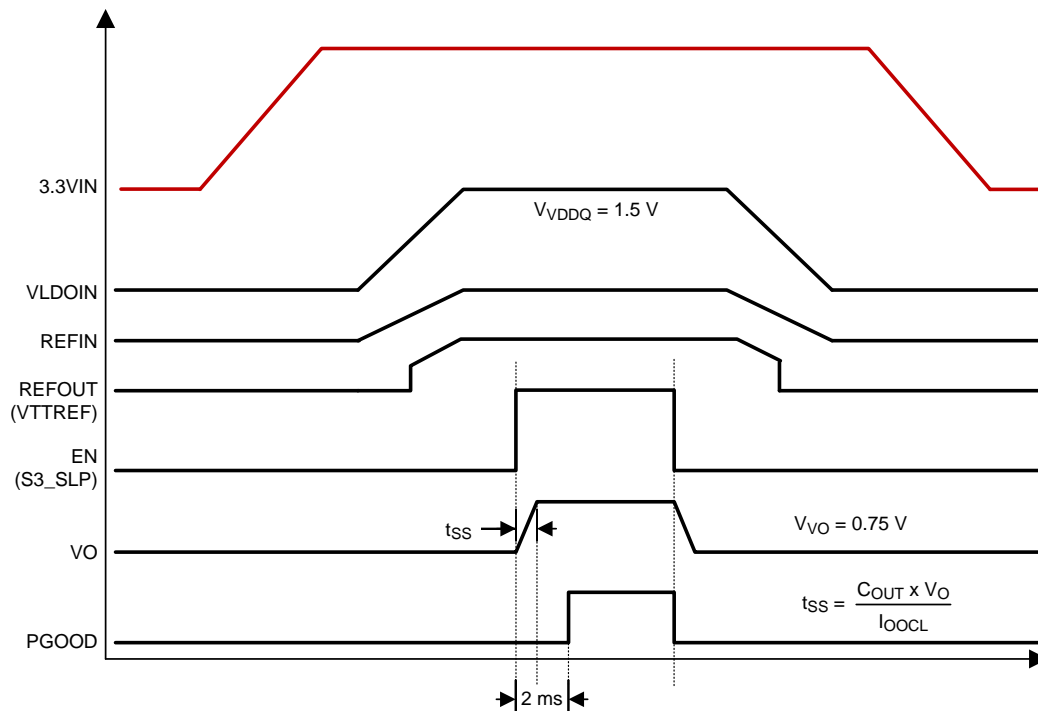


Figure 16. Typical Timing Diagram for S3 and Pseudo-S5 Support

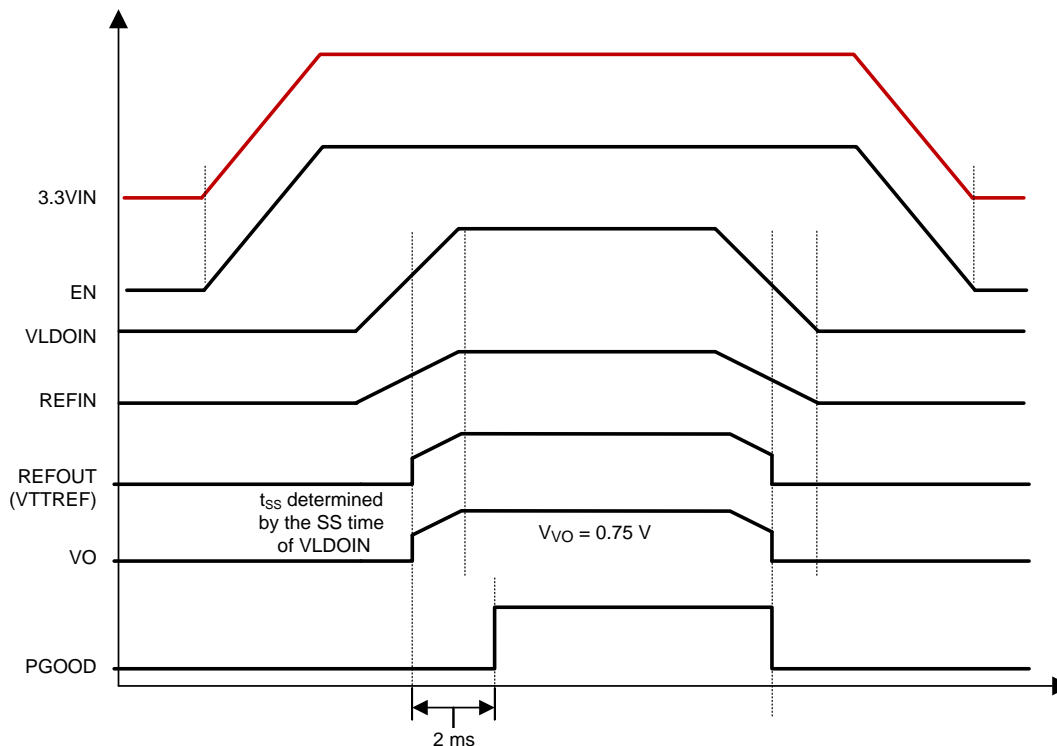
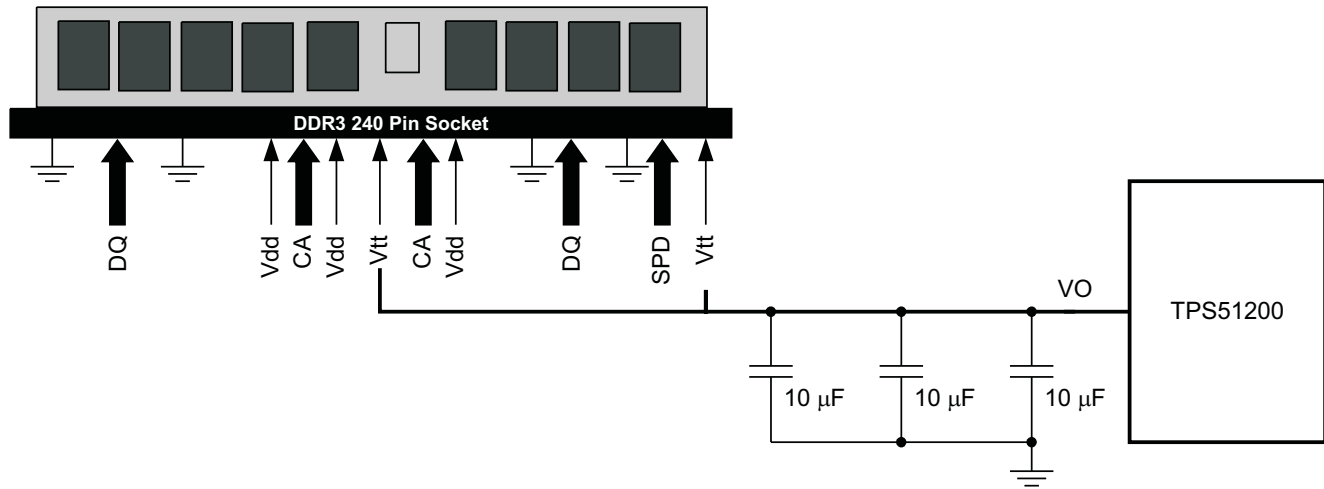


Figure 17. Typical Timing Diagram of Tracking Start-up and Shutdown

## Feature Description (continued)

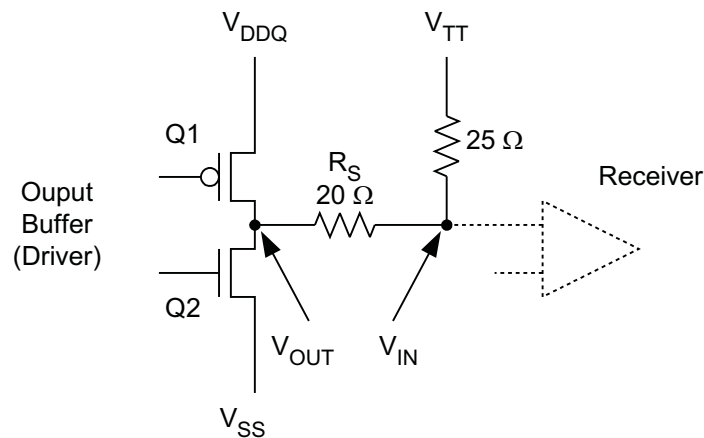
### 7.3.11 Output Tolerance Consideration for VTT DIMM Applications

The TPS51200 is specifically designed to power up the memory termination rail (as shown in Figure 18). The DDR memory termination structure determines the main characteristics of the VTT rail, which is to be able to sink and source current while maintaining acceptable VTT tolerance. See Figure 19 for typical characteristics for a single memory cell.



UDG-08022

**Figure 18. Typical Application Diagram for DDR3 VTT DIMM using TPS51200**



UDG-08023

**Figure 19. DDR Physical Signal System Bi-Directional SSTL Signaling**

In Figure 19, when Q1 is on and Q2 is off:

- Current flows from VDDQ via the termination resistor to VTT
- VTT sinks current

In Figure 19, when Q2 is on and Q1 is off:

- Current flows from VTT via the termination resistor to GND
- VTT sources current

## Feature Description (continued)

Because VTT accuracy has a direct impact on the memory signal integrity, it is imperative to understand the tolerance requirement on VTT. Equation 1 applies to both DC and AC conditions and is based on JEDEC VTT specifications for DDR and DDR2 (JEDEC standard: DDR JESD8-9B May 2002; DDR2 JESD8-15A Sept 2003).

$$V_{VTTREF} - 40 \text{ mV} < V_{VTT} < V_{VTTREF} + 40 \text{ mV} \quad (1)$$

The specification itself indicates that VTT must keep track of VTTREF for proper signal conditioning.

The TPS51200 ensures the regulator output voltage to be as shown in Equation 2, which applies to both DC and AC conditions.

$$V_{VTTREF} - 25 \text{ mV} < V_{VTT} < V_{VTTREF} + 25 \text{ mV}$$

where

- $-2 \text{ A} < I_{VTT} < 2 \text{ A}$  (2)

The regulator output voltage is measured at the regulator side, not the load side. The tolerance is applicable to DDR, DDR2, DDR3, Low Power DDR3, and DDR4 applications (see Table 2 for detailed information). To meet the stability requirement, a minimum output capacitance of 20  $\mu\text{F}$  is needed. Considering the actual tolerance on the MLCC capacitors, three 10- $\mu\text{F}$  ceramic capacitors sufficiently meet the VTT accuracy requirement.

**Table 2. DDR, DDR2, DDR3 and LP DDR3 Termination Technology**

	DDR	DDR2	DR3	LOW POWER DDR3
FSB Data Rates	200, 266, 333, and 400 MHz	400, 533, 677, and 800 MHz	800, 1066, 1330, and 1600 MHz	
Termination	Motherboard termination to VTT for all signals	On-die termination for data group. VTT termination for address, command and control signals	On-die termination for data group. VTT termination for address, command and control signals	
Termination Current Demand	Maximum source/sink transient currents of up to 2.6 A to 2.9 A	Not as demanding	Not as demanding	
		Only 34 signals (address, command, control) tied to VTT	Only 34 signals (address, command, control) tied to VTT	
		ODT handles data signals	ODT handles data signals	
		Less than 1-A of burst current	Less than 1-A of burst current	
Voltage Level	2.5-V Core and I/O 1.25-V VTT	1.8-V Core and I/O 0.9-V VTT	1.5-V Core and I/O 0.75-V VTT	1.2-V Core and I/O 0.6-V VTT

The TPS51200 uses transconductance ( $g_M$ ) to drive the LDO. The transconductance and output current of the device determine the voltage droop between the reference input and the output regulator. The typical transconductance level is 250 S at 2 A and changes with respect to the load in order to conserve the quiescent current (that is, the transconductance is very low at no load condition). The ( $g_M$ ) LDO regulator is a single pole system. Only the output capacitance determines the unity gain bandwidth for the voltage loop, as a result of the bandwidth nature of the transconductance (see Equation 3).

$$f_{UGBW} = \frac{g_M}{2 \times \pi \times C_{OUT}}$$

where

- $f_{UGBW}$  is the unity gain bandwidth
- $g_M$  is transconductance
- $C_{OUT}$  is the output capacitance (3)

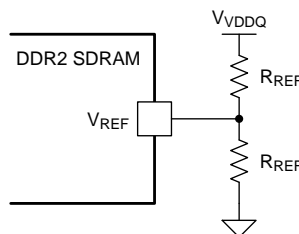
Consider these two limitations to this type of regulator that come from the output bulk capacitor requirement. In order to maintain stability, the zero location contributed by the ESR of the output capacitors must be greater than the  $-3\text{-dB}$  point of the current loop. This constraint means that higher ESR capacitors should not be used in the design. In addition, the impedance characteristics of the ceramic capacitor should be well understood in order to prevent the gain peaking effect around the transconductance ( $g_M$ )  $-3\text{-dB}$  point because of the large ESL, the output capacitor and parasitic inductance of the VO pin voltage trace.

### 7.3.12 REFOUT ( $V_{REF}$ ) Consideration for DDR2 Applications

During TPS51200 tracking start-up, the REF<sub>IN</sub> voltage follows the rise of the VDDQ rail through a voltage divider, and REF<sub>OUT</sub> ( $V_{REF}$ ) follows REF<sub>IN</sub> once the REF<sub>IN</sub> voltage is greater than 0.39 V. When the REF<sub>IN</sub> voltage is lower than 0.39 V,  $V_{REF}$  is 0 V.

The JEDEC *DDR2 SDRAM Standard (JESD79-2E)* states that  $V_{REF}$  must track VDDQ/2 within  $\pm 0.3$  V accuracy during the start-up period. To allow the TPS51200

device to meet the JEDEC DDR2 specification, a resistor divider can be used to provide the  $V_{REF}$  signal to the DIMM. The resistor divider ratio is 0.5 to ensure that the  $V_{REF}$  voltage equals VDDQ/2.



**Figure 20. Resistor Divider Circuit**

When selecting the resistor value, consider the impact of the leakage current from the DIMM  $V_{REF}$  pin on the reference voltage. Use [Equation 4](#) to calculate resistor values.

$$R_{REF} \leq \frac{2 \times \Delta V_{REF}}{I_{REF}}$$

where

- $R_{REF}$  is the resistor value
  - $\Delta V_{REF}$  is the  $V_{REF}$  DC variation requirement
  - $I_{REF}$  is the maximum total  $V_{REF}$  leakage current from DIMMs
- (4)

Consider the MT47H64M16 DDR2 SDRAM component from Micron as an example. The [MT47H64M16](#) datasheet shows the maximum  $V_{REF}$  leakage current of each DIMM is  $\pm 2$   $\mu$ A, and  $V_{REF(DC)}$  variation must be within  $\pm 1\%$  of VDDQ. In this DDR2 application, the VDDQ voltage is 1.8 V. Assuming one TPS51200 device needs to power 4 DIMMs, the maximum total  $V_{REF}$  leakage current is  $\pm 8$   $\mu$ A. Based on the calculations, the resistor value should be lower than 4.5 k $\Omega$ . To ensure sufficient margin, 100  $\Omega$  is the suggested resistor value. With two 100- $\Omega$  resistors, the maximum  $V_{REF}$  variation is 0.4 mV, and the power loss on each resistor is 8.1 mW.

## 7.4 Device Functional Modes

### 7.4.1 Low Input Voltage Applications

TPS51200 can be used in an application system that offers either a 2.5-V rail or a 3.3-V rail. If only a 5-V rail is available, consider using the [TPS51100](#) device as an alternative. The TPS51200 device has a minimum input voltage requirement of 2.375 V. If a 2.5-V rail is used, ensure that the absolute minimum voltage (both DC and transient) at the device pin is be 2.375 V or greater. The voltage tolerance for a 2.5-V rail input is between –5% and 5% accuracy, or better.

### 7.4.2 S3 and Pseudo-S5 Support

The TPS51200 provides S3 support by an EN function. The EN pin could be connected to an SLP\_S3 signal in the end application. Both REFOUT and VO are on when EN = high (S0 state). REFOUT is maintained while VO is turned off and discharged via an internal discharge MOSFET when EN = low (S3 state). When EN = low and the REFIN voltage is less than 0.390 V, TPS51200 enters pseudo-S5 state. Both VO and REFOUT outputs are turned off and discharged to GND through internal MOSFETs when pseudo-S5 support is engaged (S4 or S5 state). [Figure 16](#) shows a typical start-up and shutdown timing diagram for an application that uses S3 and pseudo-S5 support.

## 8 Application and Implementation

### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 8.1 Application Information

### 8.2 Typical Application

This design example describes a 3.3- $V_{IN}$ , DDR3 configuration.

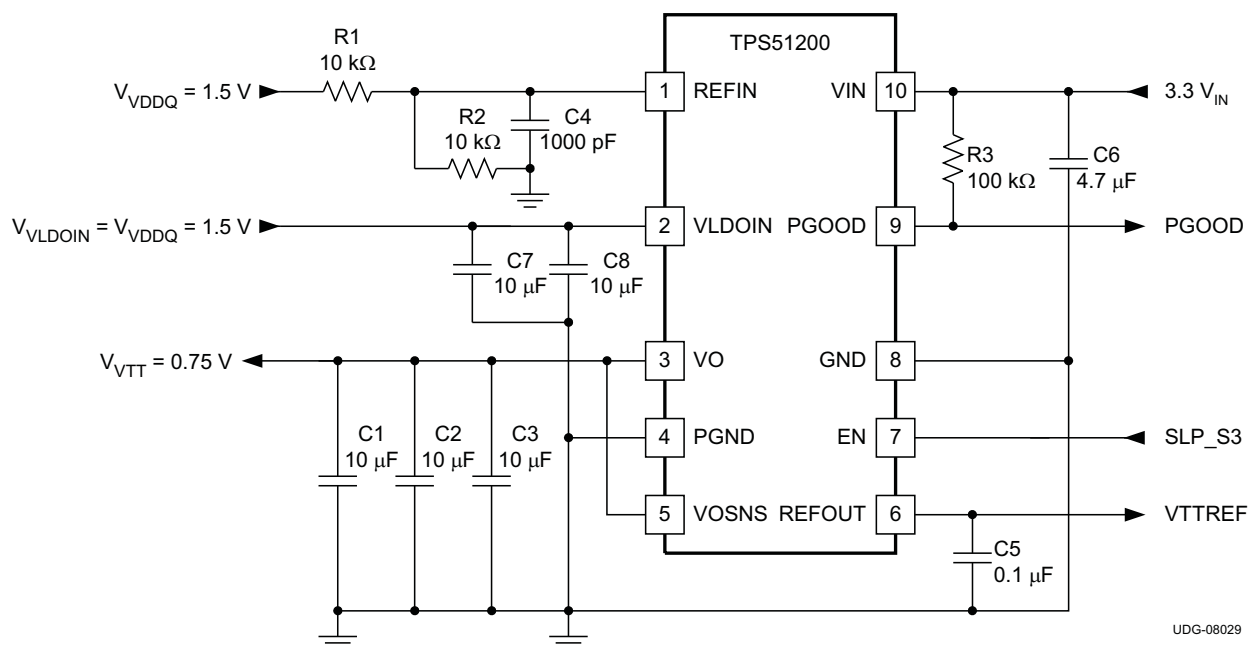


Figure 21. 3.3- $V_{IN}$ , DDR3 Configuration

Table 3. 3.3- $V_{IN}$ , DDR3 Application List of Materials

REFERENCE DESIGNATOR	DESCRIPTION	SPECIFICATION	PART NUMBER	MANUFACTURER
R1, R2	Resistor	10 kΩ		
R3		100 kΩ		
C1, C2, C3	Capacitor	10 μF, 6.3 V	GRM21BR70J106KE76L	Murata
C4		1000 pF		
C5		0.1 μF		
C6		4.7 μF, 6.3 V	GRM21BR60J475KA11L	Murata
C7, C8		10 μF, 6.3 V	GRM21BR70J106KE76L	Murata



## 8.2.1 Design Requirements

- $V_{IN} = 3.3\text{ V}$
- $V_{DDDQ} = 1.5\text{ V}$
- $V_{VLDOIN} = V_{VDDQ} = 1.5\text{ V}$
- $V_{VTT} = 0.75\text{ V}$

## 8.2.2 Detailed Design Procedure

### 8.2.2.1 Input Voltage Capacitor

Add a ceramic capacitor, with a value between 1.0- $\mu\text{F}$  and 4.7- $\mu\text{F}$ , placed close to the VIN pin, to stabilize the bias supply (2.5-V rail or 3.3-V rail) from any parasitic impedance from the supply.

### 8.2.2.2 VLDO Input Capacitor

Depending on the trace impedance between the VLDOIN bulk power supply to the device, a transient increase of source current is supplied mostly by the charge from the VLDOIN input capacitor. Use a 10- $\mu\text{F}$  (or greater) ceramic capacitor to supply this transient charge. Provide more input capacitance as more output capacitance is used at the VO pin. In general, use one-half of the  $C_{OUT}$  value for input.

### 8.2.2.3 Output Capacitor

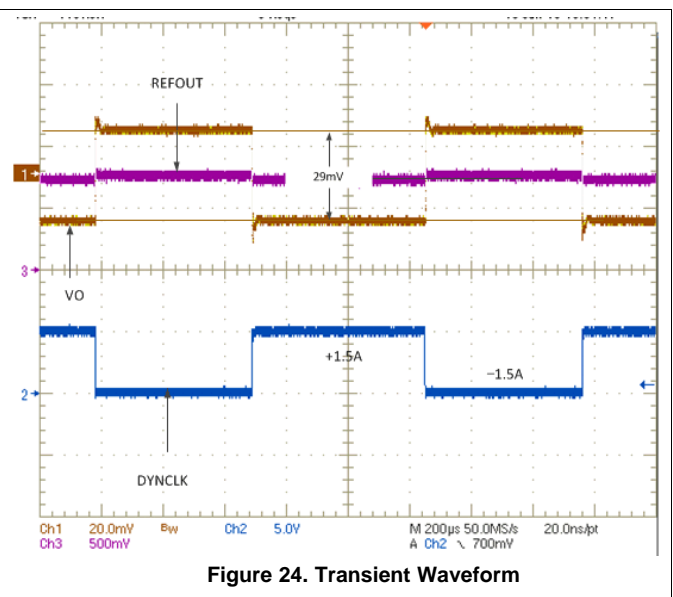
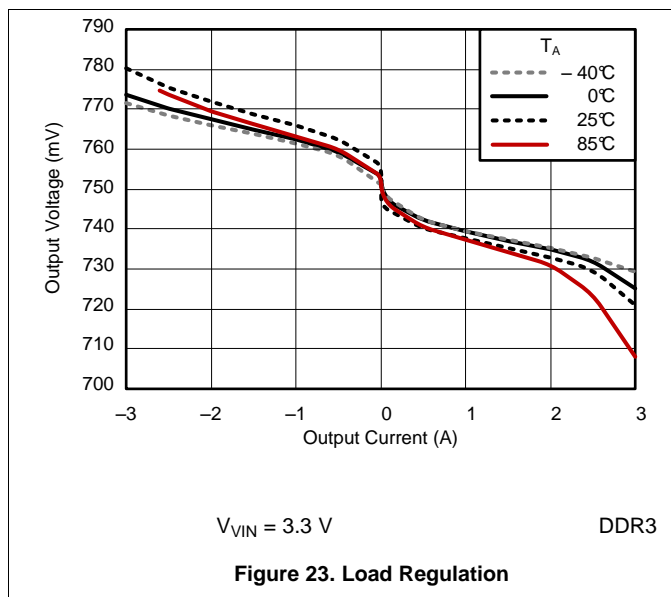
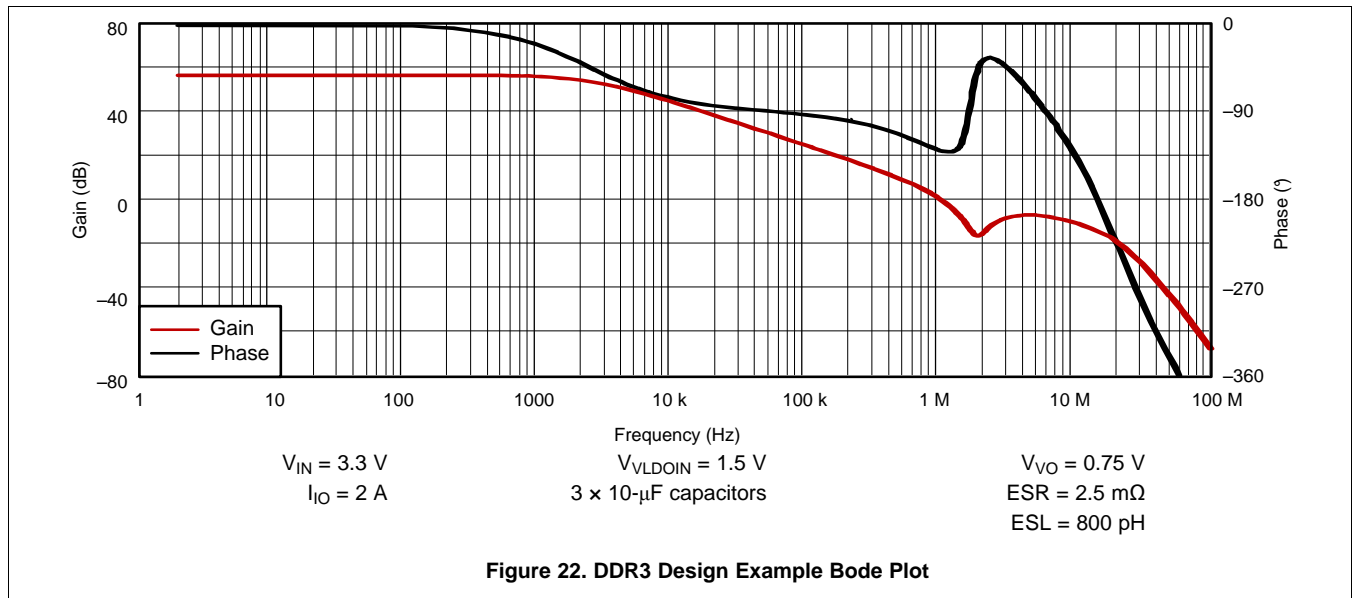
For stable operation, the total capacitance of the VO output pin must be greater than 20  $\mu\text{F}$ . Attach three, 10- $\mu\text{F}$  ceramic capacitors in parallel to minimize the effect of equivalent series resistance (ESR) and equivalent series inductance (ESL). If the ESR is greater than 2 m $\Omega$ , insert an RC filter between the output and the VOSNS input to achieve loop stability. The RC filter time constant should be almost the same as or slightly lower than the time constant of the output capacitor and its ESR.

### 8.2.3 Application Curves

Figure 22 shows the bode plot simulation for this DDR3 design example of the TPS51200 device.

The unity-gain bandwidth is approximately 1 MHz and the phase margin is 52°. The 0-dB level is crossed, the gain peaks because of the ESL effect. However, the peaking maintains a level well below 0 dB.

Figure 23 shows the load regulation and Figure 24 shows the transient response for a typical DDR3 configuration. When the regulator is subjected to ±1.5-A load step and release, the output voltage measurement shows no difference between the dc and ac conditions.



### 8.3 System Examples

#### 8.3.1 3.3- $V_{IN}$ , DDR2 Configuration

This section describes a 3.3- $V_{IN}$ , DDR2 configuration application.

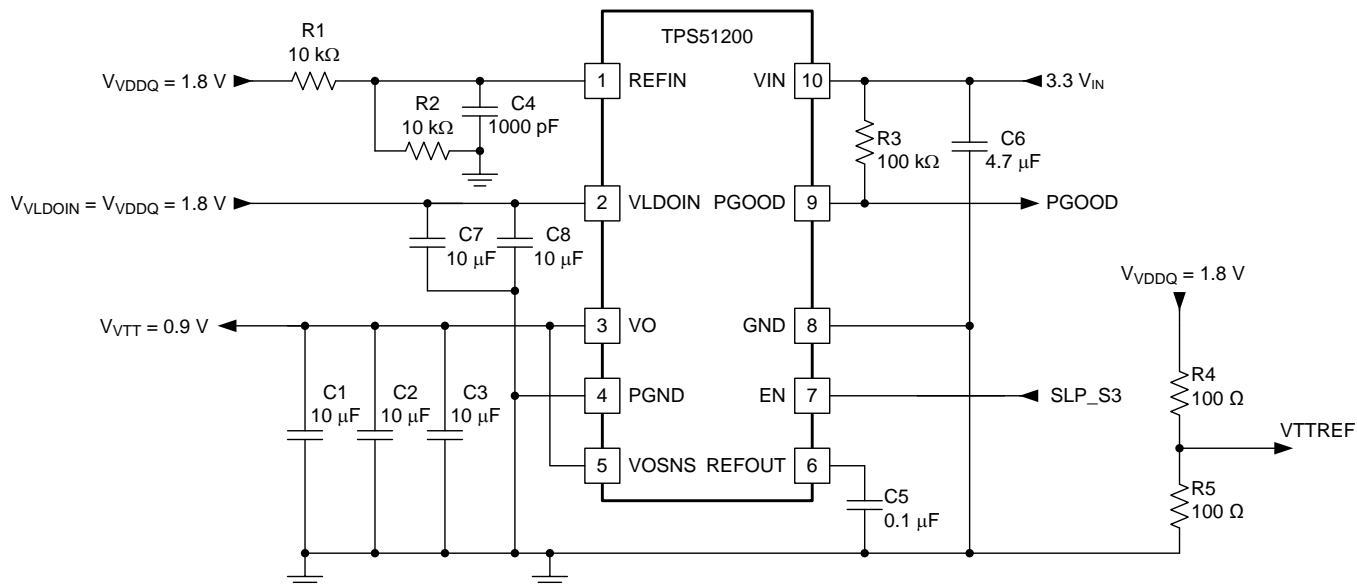


Figure 25. 3.3- $V_{IN}$ , DDR2 Configuration

Table 4. 3.3- $V_{IN}$ , DDR2 Configuration List of Materials

REFERENCE DESIGNATOR	DESCRIPTION	SPECIFICATION	PART NUMBER	MANUFACTURER
R1, R2	Resistor	10 kΩ		
R3		100 kΩ		
R4, R5		100 Ω		
C1, C2, C3	Capacitor	10 μF, 6.3 V	GRM21BR70J106KE76L	Murata
C4		1000 pF		
C5		0.1 μF		
C6		4.7 μF, 6.3 V	GRM21BR60J475KA11L	Murata
C7, C8		10 μF, 6.3 V	GRM21BR70J106KE76L	Murata

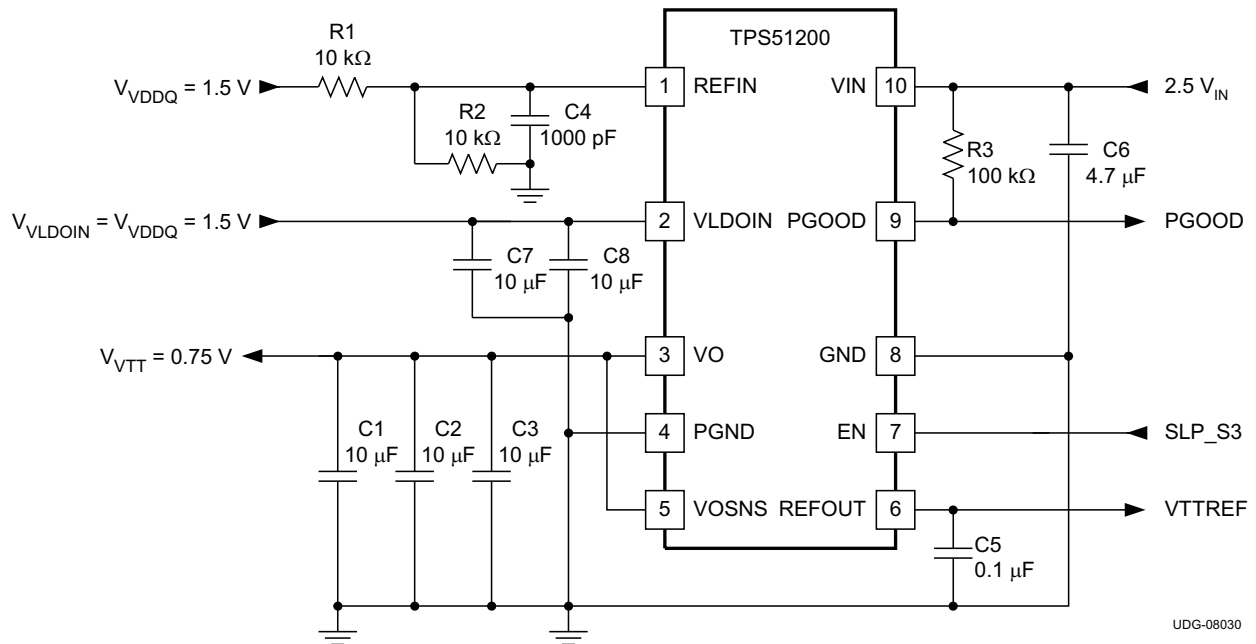
# TPS51200

SLUS812B – FEBRUARY 2008 – REVISED SEPTEMBER 2016

www.ti.com

## 8.3.2 2.5-V<sub>IN</sub>, DDR3 Configuration

This design example describes a 2.5-V<sub>IN</sub>, DDR3 configuration application.



UDG-08030

Figure 26. 2.5-V<sub>IN</sub>, DDR3 Configuration

Table 5. 2.5-V<sub>IN</sub>, DDR3 Configuration List of Materials

REFERENCE DESIGNATOR	DESCRIPTION	SPECIFICATION	PART NUMBER	MANUFACTURER
R1, R2	Resistor	10 kΩ		
R3		100 kΩ		
C1, C2, C3	Capacitor	10 µF, 6.3 V	GRM21BR70J106KE76L	Murata
C4		1000 pF		
C5		0.1 µF		
C6		4.7 µF, 6.3 V	GRM21BR60J475KA11L	Murata
C7, C8		10 µF, 6.3 V	GRM21BR70J106KE76L	Murata

### 8.3.3 3.3-V<sub>IN</sub>, LP DDR3 or DDR4 Configuration

This example describes a 3.3-V<sub>IN</sub>, LP DDR3 or DDR4 configuration application.

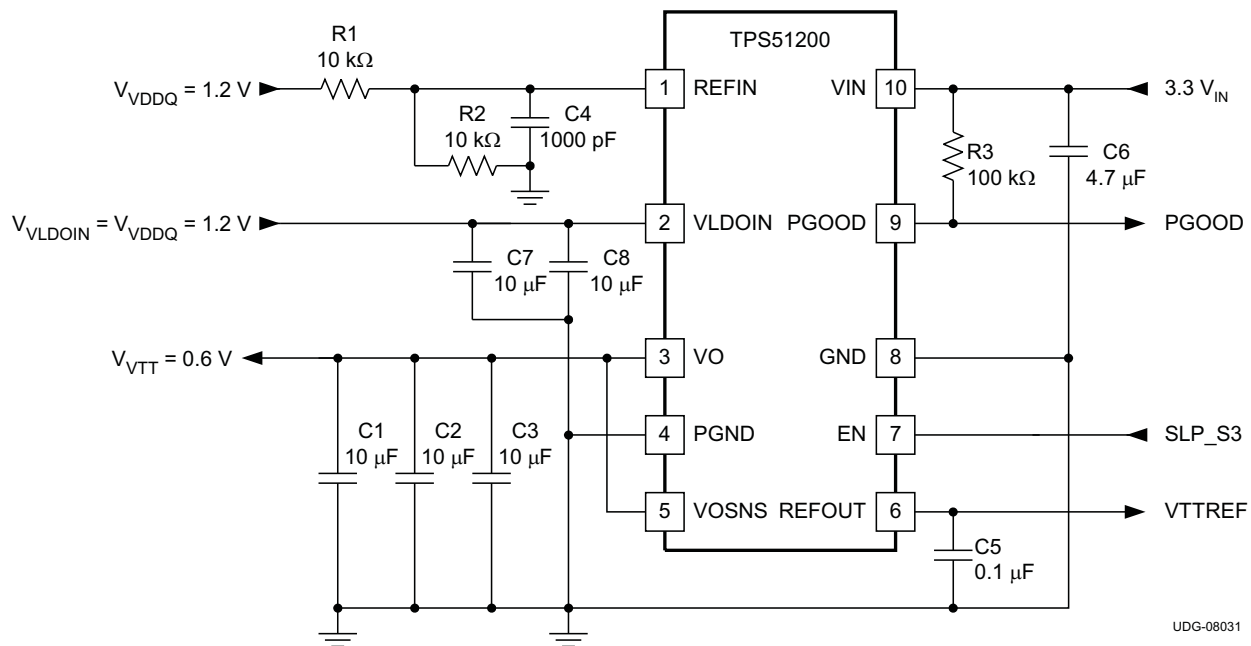


Figure 27. 3.3-V<sub>IN</sub>, LP DDR3 or DDR4 Configuration

Table 6. 3.3-V<sub>IN</sub>, LP DDR3 or DDR4 Configuration

REFERENCE DESIGNATOR	DESCRIPTION	SPECIFICATION	PART NUMBER	MANUFACTURER
R1, R2	Resistor	10 kΩ		
R3		100 kΩ		
C1, C2, C3	Capacitor	10 μF, 6.3 V	GRM21BR70J106KE76L	Murata
C4		1000 pF		
C5		0.1 μF		
C6		4.7 μF, 6.3 V	GRM21BR60J475KA11L	Murata
C7, C8		10 μF, 6.3 V	GRM21BR70J106KE76L	Murata

### 8.3.4 3.3- $V_{IN}$ , DDR3 Tracking Configuration

This design example describes a 3.3- $V_{IN}$ , DDR3 tracking configuration application.

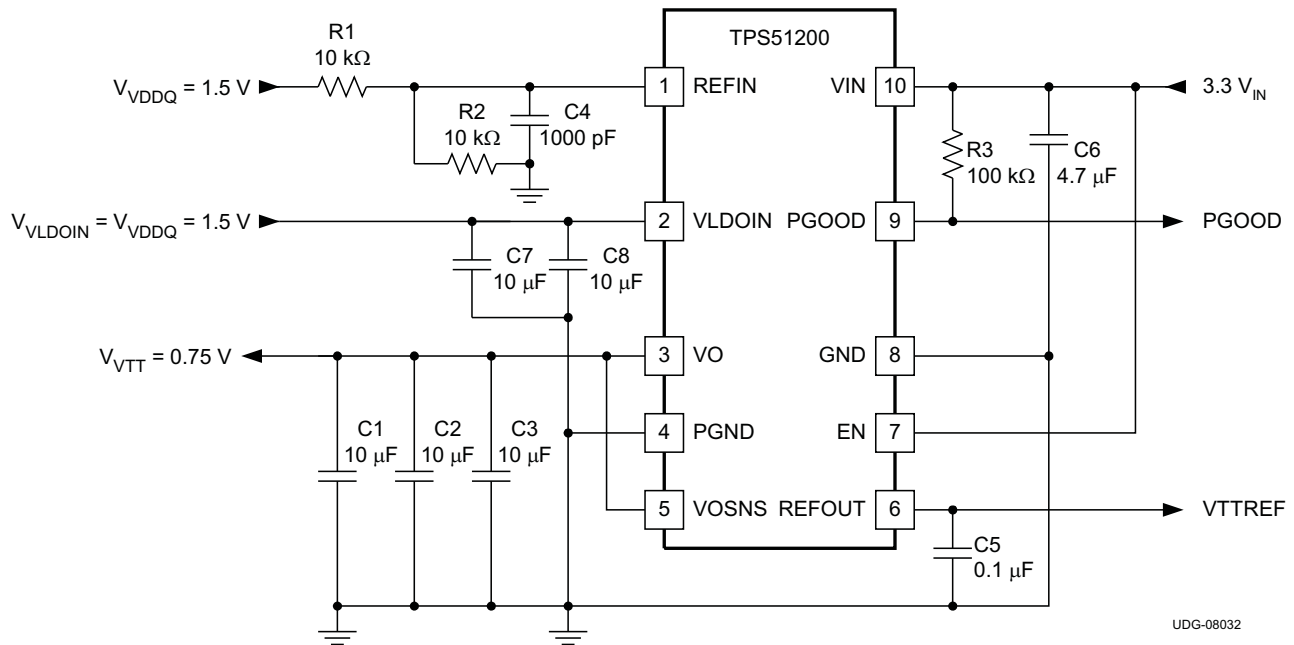


Figure 28. 3.3- $V_{IN}$ , DDR3 Tracking Configuration

Table 7. 3.3- $V_{IN}$ , DDR3 Tracking Configuration List of Materials

REFERENCE DESIGNATOR	DESCRIPTION	SPECIFICATION	PART NUMBER	MANUFACTURER
R1, R2	Resistor	10 kΩ		
R3		100 kΩ		
C1, C2, C3	Capacitor	10 μF, 6.3 V	GRM21BR70J106KE76L	Murata
C4		1000 pF		
C5		0.1 μF		
C6		4.7 μF, 6.3 V	GRM21BR60J475KA11L	Murata
C7, C8		10 μF, 6.3 V	GRM21BR70J106KE76L	Murata

### 8.3.5 3.3-V<sub>IN</sub>, LDO Configuration

This example describes a 3.3-V<sub>IN</sub>, LDO configuration application.

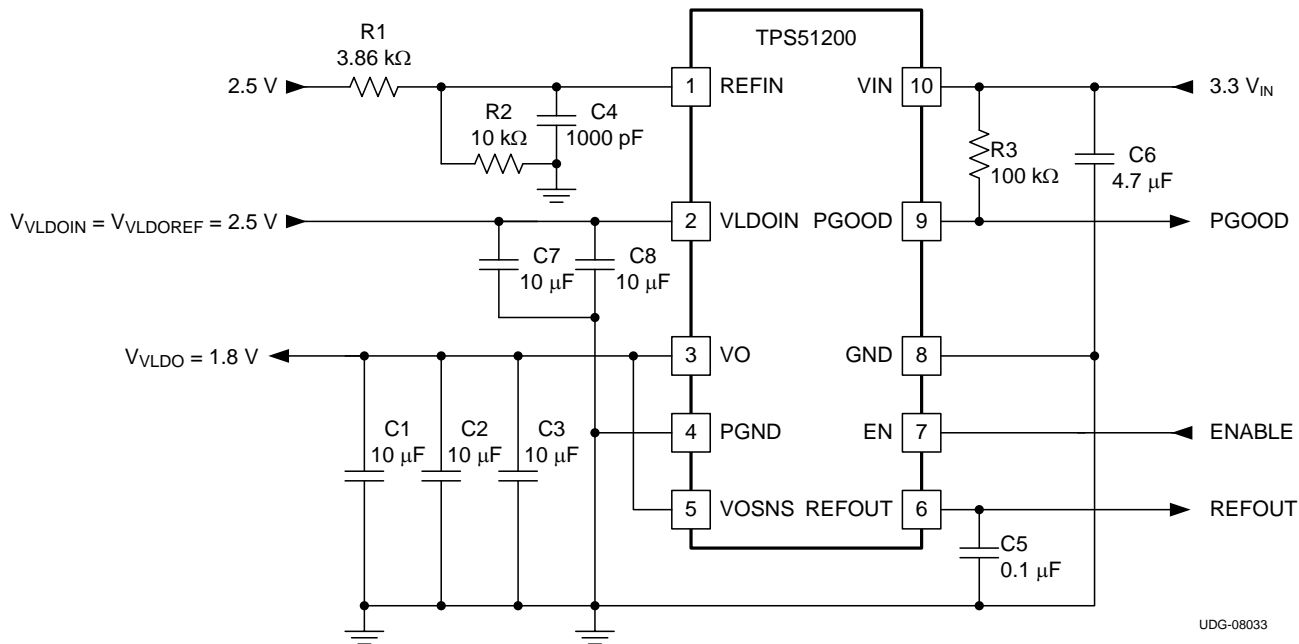


Figure 29. 3.3-V<sub>IN</sub>, LDO Configuration

Table 8. 3.3-V<sub>IN</sub>, LDO Configuration List of Materials

REFERENCE DESIGNATOR	DESCRIPTION	SPECIFICATION	PART NUMBER	MANUFACTURER
R1	Resistor	3.86 kΩ		
R2		10 kΩ		
R3		100 kΩ		
C1, C2, C3	Capacitor	10 μF, 6.3 V	GRM21BR70J106KE76L	Murata
C4		1000 pF		
C5		0.1 μF		
C6		4.7 μF, 6.3 V	GRM21BR60J475KA11L	Murata
C7, C8		10 μF, 6.3 V	GRM21BR70J106KE76L	Murata

### 8.3.6 3.3-V<sub>IN</sub>, DDR3 Configuration with LFP

This design example describes a 3.3-V<sub>IN</sub>, DDR3 configuration with LFP application.

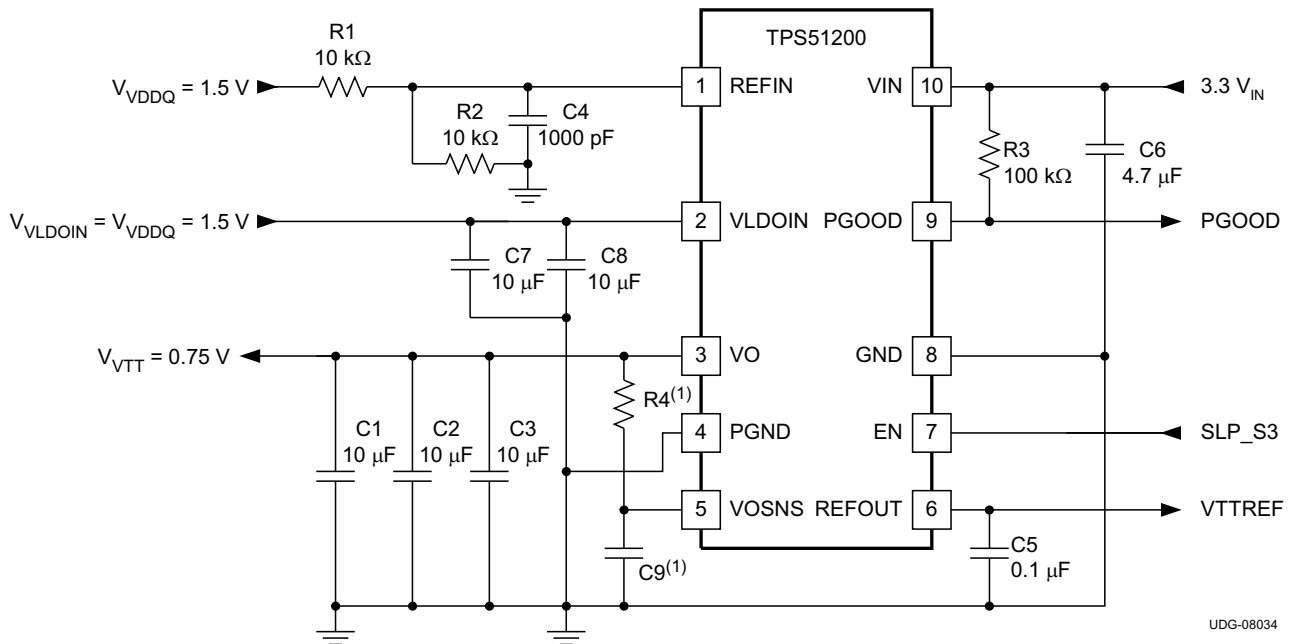


Figure 30. 3.3-V<sub>IN</sub>, DDR3 Configuration with LFP

Table 9. 3.3-V<sub>IN</sub>, DDR3 Configuration with LFP List of Materials

REFERENCE DESIGNATOR	DESCRIPTION	SPECIFICATION	PART NUMBER	MANUFACTURER
R1, R2	Resistor	10 kΩ		
R3		100 kΩ		
R4 <sup>(1)</sup>				
C1, C2, C3	Capacitor	10 μF, 6.3 V	GRM21BR70J106KE76L	Murata
C4		1000 pF		
C5		0.1 μF		
C6		4.7 μF, 6.3 V	GRM21BR60J475KA11L	Murata
C7, C8		10 μF, 6.3 V	GRM21BR70J106KE76L	Murata
C9 <sup>(1)</sup>				

(1) Choose values for R4 and C9 to reduce the parasitic effect of the trace (between VO and the output MLCCs) and the output capacitors (ESR and ESL).



## 9 Power Supply Recommendations

This device is designed to operate from an input bias voltage from 2.375 V to 3.5 V, with LDO input from 1.1 V to 3.5 V. Refer to [Figure 16](#) and [Figure 17](#) for recommended power-up sequence. Maintain a EN voltage equal or lower than  $V_{VIN}$  at all times. VLDOIN can ramp up earlier than  $V_{IN}$  if the sequence in [Figure 16](#) and [Figure 17](#) cannot be used. The input supplies should be well regulated. VLDOIN decoupling capacitance of  $2 \times 10 \mu\text{F}$  is recommended, and  $V_{IN}$  decoupling capacitance of  $1 \times 4.7 \mu\text{F}$  is recommended.

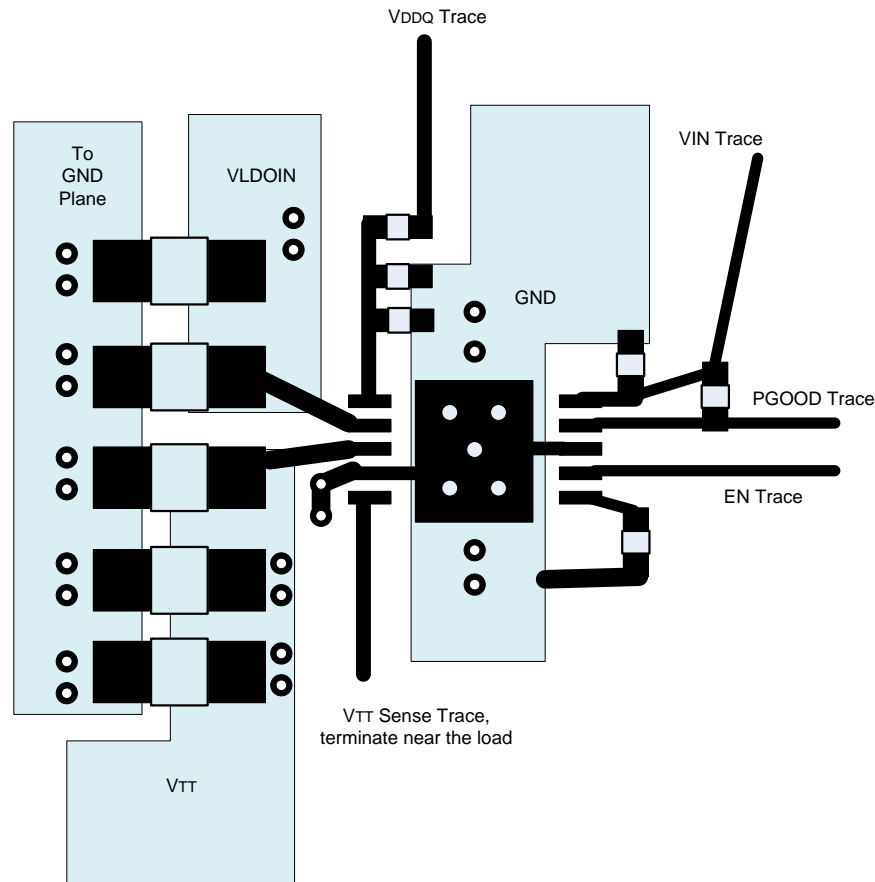
## 10 Layout

### 10.1 Layout Guidelines

Consider the following points before starting the TPS51200 device layout design.

- Place the input capacitors as close to VDLOIN pin as possible with short and wide connection.
- Place the output capacitor as close to VO pin as possible with short and wide connection. Place a ceramic capacitor with a value of at least 10- $\mu\text{F}$  as close to VO pin if the rest of output capacitors need to be placed on the load side.
- Connect the VOSNS pin to the positive node of output capacitors as a separate trace. In DDR VTT application, connect the VO sense trace to DIMM side to ensure the VTT voltage at DIMM side is well regulated.
- Consider adding low-pass filter at VOSNS if the VO sense trace is very long.
- Connect the GND pin and PGND pin to the thermal pad directly.
- TPS51200 uses its thermal pad to dissipate heat. In order to effectively remove heat from TPS51200 package, place numerous ground vias on the thermal pad. Use large ground copper plane, especially the copper plane on surface layer, to pour over those vias on thermal pad.
- Consult the TPS51200EVM User's Guide ([SLUU323](#)) for detailed layout recommendations.

## 10.2 Layout Example



**Figure 31. Layout Recommendation**

## 10.3 Thermal Design Considerations

Because the TPS51200 is a linear regulator, the  $V_O$  current flows in both source and sink directions, thereby dissipating power from the device. When the device is sourcing current, the voltage difference shown in Equation 5 calculates the power dissipation.

$$P_{D\_SRC} = (V_{VLDOIN} - V_{VO}) \times I_{O\_SRC} \quad (5)$$

In this case, if the VLDOIN pin is connected to an alternative power supply lower than the  $V_{DDQ}$  voltage, overall power loss can be reduced. During the sink phase, the device applies the  $V_O$  voltage across the internal LDO regulator. Equation 6 calculates the power dissipation,  $P_{D\_SNK}$  can be calculated by .

$$P_{D\_SNK} = V_{VO} \times I_{SNK} \quad (6)$$

Because the device does not sink and source current at the same time and the I/O current may vary rapidly with time, the actual power dissipation should be the time average of the above dissipations over the thermal relaxation duration of the system. The current used for the internal current control circuitry from the VIN supply and the VLDOIN supply are other sources of power consumption. This power can be estimated as 5 mW or less during normal operating conditions and must be effectively dissipated from the package.

### Thermal Design Considerations (continued)

Maximum power dissipation allowed by the package is calculated by [Equation 7](#).

$$P_{PKG} = \frac{T_{J(max)} - T_{A(max)}}{\theta_{JA}}$$

where

- $T_{J(max)}$  is 125°C
- $T_{A(max)}$  is the maximum ambient temperature in the system
- $\theta_{JA}$  is the thermal resistance from junction to ambient

**NOTE**

Because [Equation 7](#) demonstrates the effects of heat spreading in the ground plane, use it as a guideline only. Do not use [Equation 7](#) to estimate actual thermal performance in real application environments.

In an application where the device is mounted on PCB, TI strongly recommends using  $\psi_{JT}$  and  $\psi_{JB}$ , as explained in the section pertaining to estimating junction temperature in the *Semiconductor and IC Package Thermal Metrics* application report, [SPRA953](#). Using the thermal metrics  $\psi_{JT}$  and  $\psi_{JB}$ , as shown in the [Thermal Information](#) table, estimate the junction temperature with corresponding formulas shown in [Equation 8](#). The older  $\theta_{JC}$  top parameter specification is listed as well for the convenience of backward compatibility.

$$T_J = T_T + \Psi_{JT} \times P_D \tag{8}$$

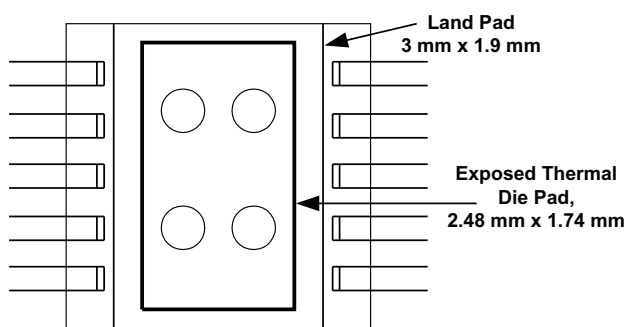
$$T_J = T_B + \Psi_{JB} \times P_D$$

where

- $P_D$  is the power dissipation shown in [Equation 5](#) and [Equation 6](#)
- $T_T$  is the temperature at the center-top of the IC package
- $T_B$  is the PCB temperature measured 1-mm away from the thermal pad package on the PCB surface (see [Figure 33](#)).

**NOTE**

Both  $T_T$  and  $T_B$  can be measured on actual application boards using a thermo-gun (an infrared thermometer). For more information about measuring  $T_T$  and  $T_B$ , see the application report *Using New Thermal Metrics* ([SBVA025](#)).



UDG-08018

Figure 32. Recommended Land Pad Pattern

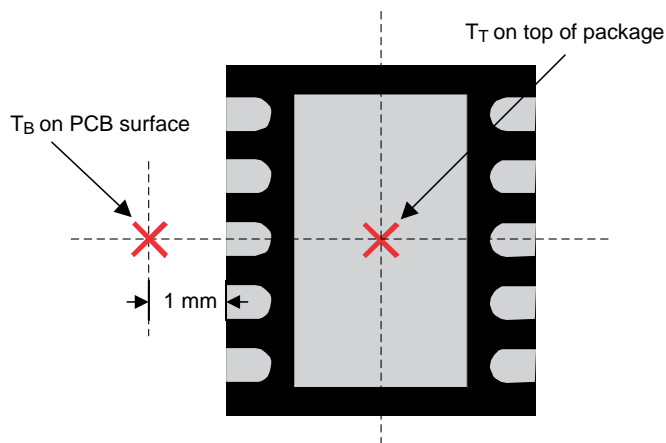


Figure 33. Package Thermal Measurement

## 11 Device and Documentation Support

### 11.1 Device Support

#### 11.1.1 Third-Party Products Disclaimer

TI'S PUBLICATION OF INFORMATION REGARDING THIRD-PARTY PRODUCTS OR SERVICES DOES NOT CONSTITUTE AN ENDORSEMENT REGARDING THE SUITABILITY OF SUCH PRODUCTS OR SERVICES OR A WARRANTY, REPRESENTATION OR ENDORSEMENT OF SUCH PRODUCTS OR SERVICES, EITHER ALONE OR IN COMBINATION WITH ANY TI PRODUCT OR SERVICE.

#### 11.1.2 Development Support

##### 11.1.2.1 Evaluation Modules

An evaluation module (EVM) is available to assist in the initial circuit performance evaluation using the TPS51200 device. The [TPS51200EVM](#) evaluation module and related user's guide ([SLUU323](#)) can be requested at the Texas Instruments website through the product folders or purchased directly from the [TI eStore](#).

##### 11.1.2.2 Spice Models

Computer simulation of circuit performance using SPICE is often useful when analyzing the performance of analog circuits and systems. A SPICE model for the TPS51200 device is available [here](#).

### 11.2 Documentation Support

#### 11.2.1 Related Documentation

- *Using New Thermal Metrics*, [SBVA025](#)
- *Semiconductor and IC Package Thermal Metrics*, [SPRA953](#)
- *Using the TPS51200 EVM Sink/Source DDR Termination Regulator*, [SLUU323](#)
- For more information on the TPS51100 device, see the product folder on [ti.com](#).

### 11.3 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

**TI E2E™ Online Community** *TI's Engineer-to-Engineer (E2E) Community*. Created to foster collaboration among engineers. At [e2e.ti.com](#), you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

### 11.4 Trademarks

E2E is a trademark of Texas Instruments.  
All other trademarks are the property of their respective owners.

### 11.5 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

### 11.6 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

## 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

**PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TPS51200DRCR	ACTIVE	VSON	DRC	10	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	1200	<a href="#">Samples</a>
TPS51200DRCRG4	ACTIVE	VSON	DRC	10	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	1200	<a href="#">Samples</a>
TPS51200DRCT	ACTIVE	VSON	DRC	10	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	1200	<a href="#">Samples</a>
TPS51200DRCTG4	ACTIVE	VSON	DRC	10	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	1200	<a href="#">Samples</a>

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSELETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

**OTHER QUALIFIED VERSIONS OF TPS51200 :**

- Automotive: [TPS51200-Q1](#)

NOTE: Qualified Version Definitions:

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

**TAPE AND REEL INFORMATION**

**QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPS51200DRCR	VSON	DRC	10	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
TPS51200DRCR	VSON	DRC	10	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
TPS51200DRCT	VSON	DRC	10	250	180.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
TPS51200DRCT	VSON	DRC	10	250	180.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2



**TAPE AND REEL BOX DIMENSIONS**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPS51200DRCR	VSON	DRC	10	3000	367.0	367.0	35.0
TPS51200DRCR	VSON	DRC	10	3000	367.0	367.0	35.0
TPS51200DRCT	VSON	DRC	10	250	210.0	185.0	35.0
TPS51200DRCT	VSON	DRC	10	250	210.0	185.0	35.0

DRC (S-PVSON-N10)

PLASTIC SMALL OUTLINE NO-LEAD



- NOTES:
- All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
  - This drawing is subject to change without notice.
  - Small Outline No-Lead (SON) package configuration.
  - The package thermal pad must be soldered to the board for thermal and mechanical performance, if present.
  - See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions, if present

# THERMAL PAD MECHANICAL DATA

DRC (S-PVSON-N10)

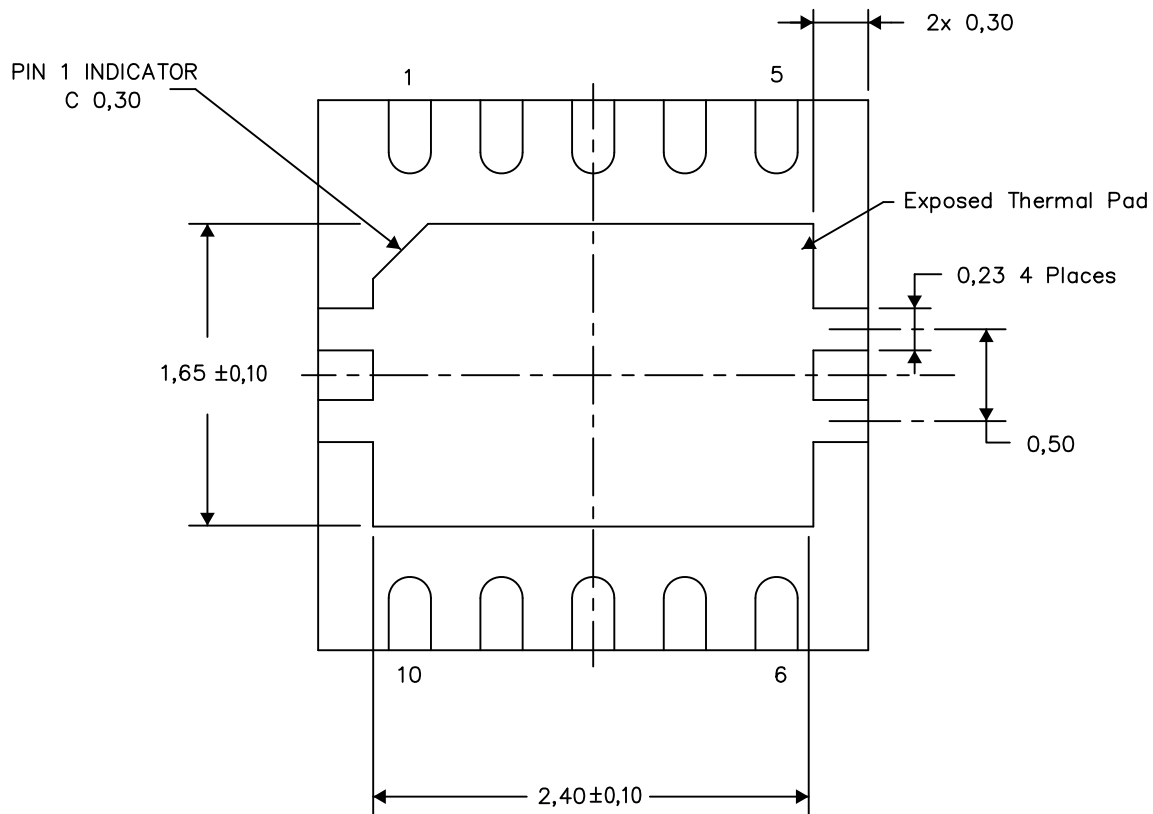
PLASTIC SMALL OUTLINE NO-LEAD

## THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at [www.ti.com](http://www.ti.com).

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

Exposed Thermal Pad Dimensions

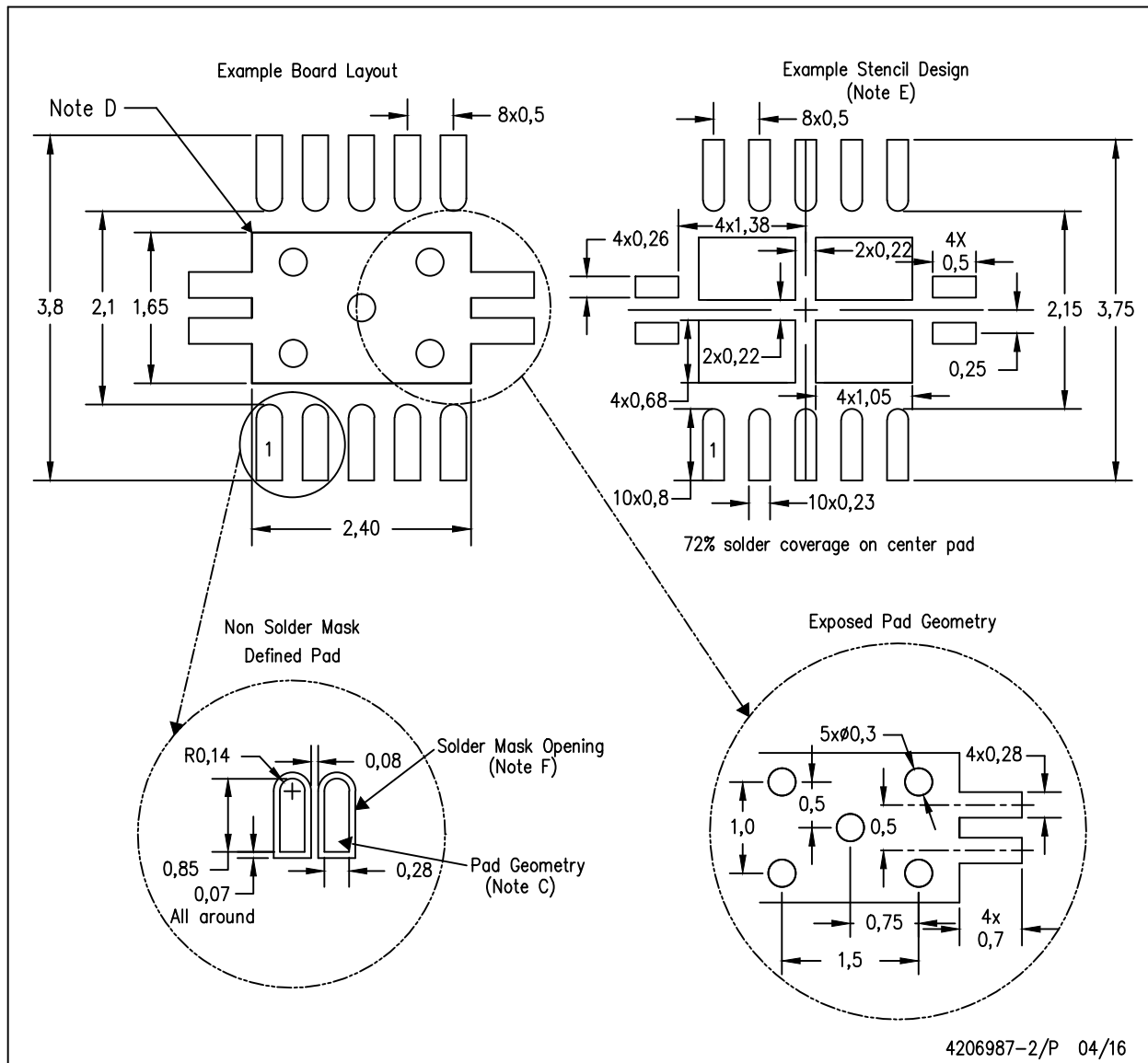
4206565-3/Y 08/15

NOTE: A. All linear dimensions are in millimeters

# LAND PATTERN DATA

DRC (S-PVSON-N10)

PLASTIC SMALL OUTLINE NO-LEAD



- NOTES:
- All linear dimensions are in millimeters.
  - This drawing is subject to change without notice.
  - Publication IPC-7351 is recommended for alternate designs.
  - This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at [www.ti.com](http://www.ti.com) <<http://www.ti.com>>.
  - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
  - Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.

## IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46, latest issue, and to discontinue any product or service per JESD48, latest issue. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have **not** been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

### Products

Audio	<a href="http://www.ti.com/audio">www.ti.com/audio</a>
Amplifiers	<a href="http://amplifier.ti.com">amplifier.ti.com</a>
Data Converters	<a href="http://dataconverter.ti.com">dataconverter.ti.com</a>
DLP® Products	<a href="http://www.dlp.com">www.dlp.com</a>
DSP	<a href="http://dsp.ti.com">dsp.ti.com</a>
Clocks and Timers	<a href="http://www.ti.com/clocks">www.ti.com/clocks</a>
Interface	<a href="http://interface.ti.com">interface.ti.com</a>
Logic	<a href="http://logic.ti.com">logic.ti.com</a>
Power Mgmt	<a href="http://power.ti.com">power.ti.com</a>
Microcontrollers	<a href="http://microcontroller.ti.com">microcontroller.ti.com</a>
RFID	<a href="http://www.ti-rfid.com">www.ti-rfid.com</a>
OMAP Applications Processors	<a href="http://www.ti.com/omap">www.ti.com/omap</a>
Wireless Connectivity	<a href="http://www.ti.com/wirelessconnectivity">www.ti.com/wirelessconnectivity</a>

### Applications

Automotive and Transportation	<a href="http://www.ti.com/automotive">www.ti.com/automotive</a>
Communications and Telecom	<a href="http://www.ti.com/communications">www.ti.com/communications</a>
Computers and Peripherals	<a href="http://www.ti.com/computers">www.ti.com/computers</a>
Consumer Electronics	<a href="http://www.ti.com/consumer-apps">www.ti.com/consumer-apps</a>
Energy and Lighting	<a href="http://www.ti.com/energy">www.ti.com/energy</a>
Industrial	<a href="http://www.ti.com/industrial">www.ti.com/industrial</a>
Medical	<a href="http://www.ti.com/medical">www.ti.com/medical</a>
Security	<a href="http://www.ti.com/security">www.ti.com/security</a>
Space, Avionics and Defense	<a href="http://www.ti.com/space-avionics-defense">www.ti.com/space-avionics-defense</a>
Video and Imaging	<a href="http://www.ti.com/video">www.ti.com/video</a>

### TI E2E Community

[e2e.ti.com](http://e2e.ti.com)

# AMEYA360

## Components Supply Platform

Authorized Distribution Brand :



Website :

Welcome to visit [www.ameya360.com](http://www.ameya360.com)

Contact Us :

➤ Address :

401 Building No.5, JiuGe Business Center, Lane 2301, Yishan Rd  
Minhang District, Shanghai , China

➤ Sales :

Direct +86 (21) 6401-6692

Email [amall@ameya360.com](mailto:amall@ameya360.com)

QQ 800077892

Skype [ameyasales1](#) [ameyasales2](#)

➤ Customer Service :

Email [service@ameya360.com](mailto:service@ameya360.com)

➤ Partnership :

Tel +86 (21) 64016692-8333

Email [mkt@ameya360.com](mailto:mkt@ameya360.com)